

CC2640R2F

SimpleLink[™] *Bluetooth*[®] 5.1 Low Energy Wireless MCU

1 Features

- Microcontroller
 - Powerful Arm[®] Cortex[®]-M3
 - EEMBC CoreMark[®] score: 142
 - Up to 48-MHz clock speed
 - 275KB of nonvolatile memory including 128KB of in-system Programmable Flash
 - Up to 28KB of system SRAM, of which 20KB is ultra-low leakage SRAM
 - 8KB of SRAM for cache or system RAM use
 - 2-Pin cJTAG and JTAG debugging
 - Supports over-the-air upgrade (OTA)
- Ultra-low power sensor controller
 - Can run autonomous from the rest of the system
 - 16-bit architecture
 - 2KB of ultra-low leakage SRAM for code and data
- Efficient code size architecture, placing drivers, TI-RTOS, and Bluetooth[®] software in ROM to make more Flash available for the application
- RoHS-compliant packages
 - 2.7-mm × 2.7-mm YFV DSBGA34 (14 GPIOs)
 - 4-mm × 4-mm RSM VQFN32 (10 GPIOs)
 - 5-mm × 5-mm RHB VQFN32 (15 GPIOs)
 - 7-mm × 7-mm RGZ VQFN48 (31 GPIOs)
- Peripherals
 - All digital peripheral pins can be routed to any GPIO
 - Four general-purpose timer modules (eight 16-bit or four 32-bit timers, PWM each)
 - 12-bit ADC, 200-ksamples/s, 8-channel analog MUX
 - Continuous time comparator
 - Ultra-low power analog comparator
 - Programmable current source
 - UART, I2C, and I2S
 - 2× SSI (SPI, MICROWIRE, TI)
 - Real-Time Clock (RTC)
 - AES-128 security module
 - True Random Number Generator (TRNG)
 - Support for eight capacitive-sensing buttons
 - Integrated temperature sensor

- External system
 - On-chip internal DC/DC converter
 - Seamless integration with CC2590 and CC2592 range extenders
 - Very few external components
 - Pin compatible with the SimpleLink™ CC2640 and CC2650 devices in all VQFN packages
 - Pin compatible with the SimpleLink[™] CC2642R and CC2652R devices in 7-mm x 7-mm VQFN packages
 - Pin compatible with the SimpleLink[™] CC1350 device in 4-mm × 4-mm and 5-mm × 5-mm VQFN packages
- Low power
 - Wide supply voltage range
 - Normal operation: 1.8 to 3.8 V
 - External regulator mode: 1.7 to 1.95 V
 - Active-Mode RX: 5.9 mA
 - Active-Mode TX at 0 dBm: 6.1 mA
 - Active-Mode TX at +5 dBm: 9.1 mA
 - Active-Mode MCU: 61 µA/MHz
 - Active-Mode MCU: 48.5 CoreMark/mA
 - Active-Mode sensor controller: 0.4mA + 8.2 µA/MHz
 - Standby: 1.1 μA (RTC running and RAM/CPU retention)
 - Shutdown: 100 nA (wake up on external events)
- RF section
 - 2.4-GHz RF transceiver compatible with Bluetooth[®] Low Energy 5.1 and earlier LE specifications
 - Excellent receiver sensitivity (–97 dBm for BLE), selectivity, and blocking performance
 - Link budget of 102 dB for BLE
 - Programmable output power up to +5 dBm
 - Single-ended or differential RF interface
 - Suitable for systems targeting compliance with worldwide radio frequency regulations
 - ETSI EN 300 328 (Europe)
 - EN 300 440 Class 2 (Europe)
 - FCC CFR47 Part 15 (US)
 - ARIB STD-T66 (Japan)

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- Development Tools and Software
 - Full-feature development kits
 - Multiple reference designs
 - SmartRF[™] Studio
 - Sensor Controller Studio
 - IAR Embedded Workbench[®] for Arm[®]
 - Code Composer Studio[™] Integrated Development Environment (IDE)
 - Code Composer Studio™ Cloud IDE

2 Applications

- Home and Building Automation
 - Connected appliances
 - Lighting
 - Smart locks
 - Gateways
 - Security Systems
- Industrial
 - Factory automation
 - Asset tracking and management

- HMI
- Access control
- Electronic Point Of Sale (EPOS)
 - Electronic Shelf Label (ESL)
- Health and Medical
 - Electronic thermometers
- SpO2
- Blood glucose monitors and blood pressure monitors
- Weigh scales
- Hearing aids
- Sports and Fitness
 - Wearable fitness and activity monitors
 - Smart trackers
 - Patient monitors
 - Fitness machines
- HID
 - Gaming
 - Pointing devices (wireless keyboard and mouse)

3 Description

The CC2640R2F device is a 2.4 GHz wireless microcontroller (MCU) supporting *Bluetooth*[®] 5.1 Low Energy and Proprietary 2.4 GHz applications. The device is optimized for low-power wireless communication and advanced sensing in building security systems, HVAC, asset tracking, and medical markets, and applications where industrial performance is required. The highlighted features of this device include:

- Support for *Bluetooth* [®] 5.1 features: LE Coded PHYs (Long Range), LE 2-Mbit PHY (High Speed), Advertising Extensions, Multiple Advertisement Sets, as well as backwards compatibility and support for key features from the *Bluetooth* [®] 5.0 and earlier Low Energy specifications.
- Fully-qualified *Bluetooth* [®] 5.1 software protocol stack included with the SimpleLink[™] CC2640R2F Software Development Kit (SDK) for developing applications on the powerful Arm[®] Cortex[®]-M3 processor.
- Longer battery life wireless applications with low standby current of 1.1 μA with full RAM retention.
- Advanced sensing with a programmable, autonomous ultra-low power Sensor Controller CPU with fast wakeup capability. As an example, the sensor controller is capable of 1-Hz ADC sampling at 1 µA system current.
- Dedicated software controlled radio controller (Arm[®] Cortex[®]-M0) providing flexible low-power RF transceiver capability to support multiple physical layers and RF standards, such as real-time localization (RTLS) technologies.
- Excellent radio sensitivity and robustness (selectivity and blocking) performance for *Bluetooth* [®] Low Energy (-103 dBm for 125-kbps LE Coded PHY).

The CC2640R2F device is part of the SimpleLink[™] microcontroller (MCU) platform, which consists of Wi-Fi[®], *Bluetooth* [®] Low Energy, Thread, ZigBee[®], Sub-1 GHz MCUs, and host MCUs that all share a common, easy-to-use development environment with a single core software development kit (SDK) and rich tool set. A one-time integration of the SimpleLink[™] platform enables you to add any combination of the portfolio's devices into your design, allowing 100 percent code reuse when your design requirements change. For more information, visit SimpleLink[™] MCU platform.

| PART NUMBER | PACKAGE | BODY SIZE (NOM) |
|--------------|-----------|-------------------|
| CC2640R2FRGZ | VQFN (48) | 7.00 mm × 7.00 mm |
| CC2640R2FRHB | VQFN (32) | 5.00 mm × 5.00 mm |
| CC2640R2FRSM | VQFN (32) | 4.00 mm × 4.00 mm |

Device Information (1)



Device Information ⁽¹⁾ (continued)

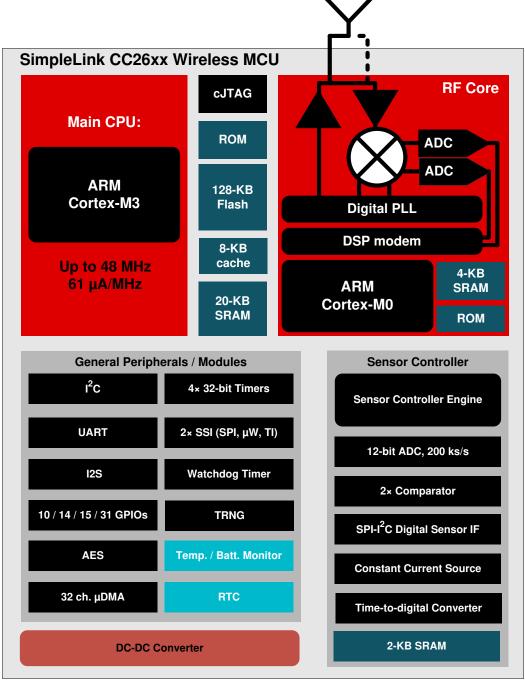
| PART NUMBER | PACKAGE | BODY SIZE (NOM) |
|--------------|------------|-------------------|
| CC2640R2FYFV | DSBGA (34) | 2.70 mm × 2.70 mm |

(1) For more information, see Section 12.



4 Functional Block Diagram

Figure 4-1 shows a block diagram for the CC2640R2F device.



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| 10.1 Application Information | 43 45 45 49 50 51 51 51 51 52 53 |



5 Revision History NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| С | Changes from Revision B (January 2018) to Revision C (September 2020) | | | | | |
|---|--|----|--|--|--|--|
| • | Updated the numbering format for tables, figures, and cross-references throughout the document | 1 | | | | |
| • | Changed intermodulation interferer frequencies in Section 8.12 | 23 | | | | |
| • | Changed Figure 8-20 in Section 8.29 | 32 | | | | |
| • | Changed IDLE value for Current in Section 9.8 | 39 | | | | |



6 Device Comparison

| | | ce i anni y v | | | |
|-----------------------------|--|---------------|----------|----------------|------------------------|
| Device | PHY Support | Flash (KB) | RAM (KB) | GPIO | Package ⁽¹⁾ |
| CC2640R2Fxxx ⁽²⁾ | Bluetooth low energy (Normal, High Speed, Long Range) | 128 | 20 | 31, 15, 14, 10 | RGZ, RHB, YFV, RSM |
| CC2640F128xxx | Bluetooth low energy (Normal) | 128 | 20 | 31, 15, 10 | RGZ, RHB, RSM |
| CC2650F128xxx | Multi-Protocol ⁽³⁾ | 128 | 20 | 31, 15, 10 | RGZ, RHB, RSM |
| CC2630F128xxx | IEEE 802.15.4 (/6LoWPAN) | 128 | 20 | 31, 15, 10 | RGZ, RHB, RSM |
| CC2620F128xxx | IEEE 802.15.4 (RF4CE) | 128 | 20 | 31, 10 | RGZ, RSM |

Table 6-1. Device Family Overview

(1) Package designator replaces the xxx in device name to form a complete device name, RGZ is 7-mm × 7-mm VQFN48, RHB is 5-mm × 5-mm VQFN32, RSM is 4-mm × 4-mm VQFN32, and YFV is 2.7-mm × 2.7-mm DSBGA.

(2) CC2640R2Fxxx devices contain Bluetooth Low Energy Host & Controller libraries in ROM, leaving more of the 128KB Flash memory available for the customer application when used with supported BLE-Stack software protocol stack releases. Actual use of ROM and Flash memory by the protocol stack may vary depending on device software configuration. See www.ti.com for more details.

(3) The CC2650 device supports all PHYs and can be reflashed to run all the supported standards.

6.1 Related Products

| TI's Wireless Connectivity | The wireless connectivity portfolio offers a wide selection of low-power RF solutions suitable for a broad range of applications. The offerings range from fully customized solutions to turn key offerings with pre-certified hardware and software (protocol). |
|---|---|
| TI's SimpleLink™ Sub-1 GHz Wireless MCUs | Long-range, low-power wireless connectivity solutions are offered in a wide range of Sub-1 GHz ISM bands. |
| Companion Products Companion Products | Review products that are frequently purchased or used in conjunction with this product. |
| SimpleLink™ CC2640R2 Wireless MCU LaunchPad™ Development Kit | The CC2640R2 LaunchPad [™] development kit brings easy Bluetooth [®] low energy (BLE) connection to the LaunchPad ecosystem with the SimpleLink ultra-low power CC26xx family of devices. Compared to the CC2650 LaunchPad, the CC2640R2 LaunchPad provides the following: |
| | More free flash memory for the user application in the CC2640R2 wireless MCU Out-of-the-box support for Bluetooth 4.2 specification 4× faster Over-the-Air download speed compared to Bluetooth 4.1 |
| SimpleLink™ Bluetooth low energy/Multi- standard SensorTag | The new SensorTag IoT kit invites you to realize your cloud-connected product idea. The new SensorTag now includes 10 low-power MEMS sensors in a tiny red package. And it is expandable with DevPacks to make it easy to add your own sensors or actuators. |
| Reference Designs for CC2640 | TI Designs Reference Design Library is a robust reference design library spanning analog, embedded processor and connectivity. Created by TI experts to help you jump-start your system design, all TI Designs include schematic or block diagrams, BOMs, and design files to speed your time to market. Search and download designs at ti.com/tidesigns. |



7 Terminal Configuration and Functions

7.1 Pin Diagram – RGZ Package

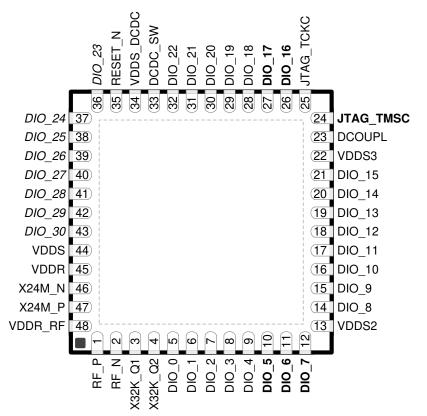


Figure 7-1. RGZ Package 48-Pin VQFN (7-mm × 7-mm) Pinout, 0.5-mm Pitch

I/O pins marked in Figure 7-1 in **bold** have high-drive capabilities; they are the following:

- Pin 10, DIO_5
- Pin 11, DIO_6
- Pin 12, DIO_7
- Pin 24, JTAG_TMSC
- Pin 26, DIO 16
- Pin 27, DIO_17

I/O pins marked in Figure 7-1 in *italics* have analog capabilities; they are the following:

- Pin 36, DIO_23
- Pin 37, DIO_24
- Pin 38, DIO 25
- Pin 39, DIO_26
- Pin 40, DIO_27
- Pin 41, DIO_28
- Pin 42, DIO_29
- Pin 43, DIO_30



7.2 Signal Descriptions – RGZ Package

Table 7-1. Signal Descriptions – RGZ Package

| NAME | NO. | TYPE | | |
|-----------|-----|----------------------------|--|--|
| DCDC_SW | 33 | Power | Output from internal DC/DC ⁽¹⁾ | |
| DCOUPL | 23 | Power | 1.27-V regulated digital-supply decoupling capacitor ⁽²⁾ | |
| DIO_0 | 5 | Digital I/O | GPIO, Sensor Controller | |
| DIO_1 | 6 | Digital I/O | GPIO, Sensor Controller | |
| DIO_2 | 7 | Digital I/O | GPIO, Sensor Controller | |
| DIO_3 | 8 | Digital I/O | GPIO, Sensor Controller | |
| | 9 | - | GPIO, Sensor Controller | |
| DIO_4 | 10 | Digital I/O Digital I/O | GPIO, Sensor Controller, high-drive capability | |
| DIO_5 | | - | | |
| DIO_6 | 11 | Digital I/O | GPIO, Sensor Controller, high-drive capability | |
| DIO_7 | 12 | Digital I/O | GPIO, Sensor Controller, high-drive capability | |
| DIO_8 | 14 | Digital I/O | GPIO | |
| DIO_9 | 15 | Digital I/O | GPIO | |
| DIO_10 | 16 | Digital I/O | GPIO | |
| DIO_11 | 17 | Digital I/O | GPIO | |
| DIO_12 | 18 | Digital I/O | GPIO | |
| DIO_13 | 19 | Digital I/O | GPIO | |
| DIO_14 | 20 | Digital I/O | GPIO | |
| DIO_15 | 21 | Digital I/O | GPIO | |
| DIO_16 | 26 | Digital I/O | GPIO, JTAG_TDO, high-drive capability | |
| DIO_17 | 27 | Digital I/O | GPIO, JTAG_TDI, high-drive capability | |
| DIO_18 | 28 | Digital I/O | GPIO | |
| DIO_19 | 29 | Digital I/O | O GPIO | |
| DIO_20 | 30 | Digital I/O | Digital I/O GPIO | |
| DIO_21 | 31 | Digital I/O | O GPIO | |
| DIO_22 | 32 | Digital I/O | GPIO | |
| DIO_23 | 36 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_24 | 37 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_25 | 38 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_26 | 39 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_27 | 40 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_28 | 41 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_29 | 42 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_30 | 43 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| JTAG_TMSC | 24 | Digital I/O | JTAG TMSC, high-drive capability | |
| JTAG_TCKC | 25 | Digital I/O | JTAG TCKC ⁽³⁾ | |
| RESET_N | 35 | Digital input | Reset, active-low. No internal pullup. | |
| RF_P | 1 | RF I/O | Positive RF input signal to LNA during RX Positive RF output signal to PA during TX | |
| RF_N | 2 | RF I/O | Negative RF input signal to LNA during RX Negative RF output signal to PA during TX | |
| VDDR | 45 | Power | 1.7-V to 1.95-V supply, typically connect to output of internal $DC/DC^{(2)}$ ⁽⁴⁾ | |
| VDDR_RF | 48 | Power | 1.7-V to 1.95-V supply, typically connect to output of internal DC/DC ^{(2) (5)} | |

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Table 7-1. Signal Descriptions – RGZ Package (continued)

| U U U | | | |
|-----------|-----|------------------|--|
| NAME | NO. | TYPE DESCRIPTION | |
| VDDS | 44 | Power | 1.8-V to 3.8-V main chip supply ⁽¹⁾ |
| VDDS2 | 13 | Power | 1.8-V to 3.8-V DIO supply ⁽¹⁾ |
| VDDS3 | 22 | Power | 1.8-V to 3.8-V DIO supply ⁽¹⁾ |
| VDDS_DCDC | 34 | Power | 1.8-V to 3.8-V DC/DC supply |
| X32K_Q1 | 3 | Analog I/O | 32-kHz crystal oscillator pin 1 |
| X32K_Q2 | 4 | Analog I/O | 32-kHz crystal oscillator pin 2 |
| X24M_N | 46 | Analog I/O | 24-MHz crystal oscillator pin 1 |
| X24M_P | 47 | Analog I/O | 24-MHz crystal oscillator pin 2 |
| EGP | | Power | Ground – Exposed Ground Pad |

(1) For more details, see the technical reference manual (listed in Section 11.3).

(2) Do not supply external circuitry from this pin.

(3) For design consideration regarding noise immunity for this pin, see the JTAG Interface chapter in the CC13x0, CC26x0 SimpleLink™ Wireless MCU Technical Reference Manual

(4) If internal DC/DC is not used, this pin is supplied internally from the main LDO.

(5) If internal DC/DC is not used, this pin must be connected to VDDR for supply from the main LDO.



7.3 Pin Diagram – RHB Package

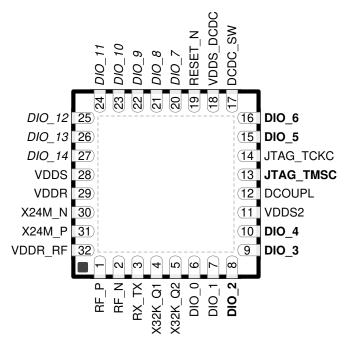


Figure 7-2. RHB Package 32-Pin VQFN (5-mm × 5-mm) Pinout, 0.5-mm Pitch

I/O pins marked in Figure 7-2 in **bold** have high-drive capabilities; they are the following:

- Pin 8, DIO_2
- Pin 9, DIO_3
- Pin 10, DIO_4
- Pin 13, JTAG_TMSC
- Pin 15, DIO_5
- Pin 16, DIO_6

I/O pins marked in Figure 7-2 in *italics* have analog capabilities; they are the following:

- Pin 20, DIO_7
- Pin 21, DIO_8
- Pin 22, DIO_9
- Pin 23, DIO_10
- Pin 24, DIO 11
- Pin 25, DIO 12
- Pin 26, DIO_13
- Pin 27, DIO_14



7.4 Signal Descriptions – RHB Package

Table 7-2. Signal Descriptions – RHB Package

| NAME | NO. | TYPE | DESCRIPTION | |
|-----------|-----|--------------------|--|--|
| DCDC_SW | 17 | Power | Output from internal DC/DC ⁽¹⁾ | |
| DCOUPL | 12 | Power | 1.27-V regulated digital-supply decoupling ⁽²⁾ | |
| DIO_0 | 6 | Digital I/O | GPIO, Sensor Controller | |
| DIO_1 | 7 | Digital I/O | GPIO, Sensor Controller | |
| DIO_2 | 8 | Digital I/O | GPIO, Sensor Controller, high-drive capability | |
| DIO_3 | 9 | Digital I/O | GPIO, Sensor Controller, high-drive capability | |
| DIO_4 | 10 | Digital I/O | GPIO, Sensor Controller, high-drive capability | |
| DIO_5 | 15 | Digital I/O | GPIO, High drive capability, JTAG_TDO | |
| DIO_6 | 16 | Digital I/O | GPIO, High drive capability, JTAG_TDI | |
| DIO_7 | 20 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_8 | 21 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_9 | 22 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_10 | 23 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_11 | 24 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_12 | 25 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_13 | 26 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_14 | 27 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| JTAG_TMSC | 13 | Digital I/O | JTAG TMSC, high-drive capability | |
| JTAG_TCKC | 14 | Digital I/O | JTAG TCKC ⁽³⁾ | |
| RESET_N | 19 | Digital input | Reset, active-low. No internal pullup. | |
| RF_N | 2 | RF I/O | Negative RF input signal to LNA during RX Negative RF output signal to PA during TX | |
| RF_P | 1 | RF I/O | Positive RF input signal to LNA during RX Positive RF output signal to PA during TX | |
| RX_TX | 3 | RF I/O | Optional bias pin for the RF LNA | |
| VDDR | 29 | Power | 1.7-V to 1.95-V supply, typically connect to output of internal DC/DC ⁽⁴⁾ (2) | |
| VDDR_RF | 32 | Power | 1.7-V to 1.95-V supply, typically connect to output of internal DC/DC ^{(2) (5)} | |
| VDDS | 28 | Power | 1.8-V to 3.8-V main chip supply ⁽¹⁾ | |
| VDDS2 | 11 | Power | 1.8-V to 3.8-V GPIO supply ⁽¹⁾ | |
| VDDS_DCDC | 18 | Power | 1.8-V to 3.8-V DC/DC supply | |
| X32K_Q1 | 4 | Analog I/O | 32-kHz crystal oscillator pin 1 | |
| X32K_Q2 | 5 | Analog I/O | 32-kHz crystal oscillator pin 2 | |
| X24M_N | 30 | Analog I/O | 24-MHz crystal oscillator pin 1 | |
| X24M_P | 31 | Analog I/O | 24-MHz crystal oscillator pin 2 | |
| EGP | | Power | Ground – Exposed Ground Pad | |
| | | | | |

(1) See technical reference manual (listed in Section 11.3) for more details.

(2) Do not supply external circuitry from this pin.

(3) For design consideration regarding noise immunity for this pin, see the JTAG Interface chapter in the CC13x0, CC26x0 SimpleLink™ Wireless MCU Technical Reference Manual

(4) If internal DC/DC is not used, this pin is supplied internally from the main LDO.

(5) If internal DC/DC is not used, this pin must be connected to VDDR for supply from the main LDO.



7.5 Pin Diagram – YFV (Chip Scale, DSBGA) Package

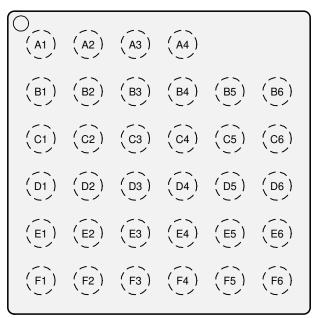


Figure 7-3. YFV (2.7-mm × 2.7-mm) Pinout, Top View

7.6 Signal Descriptions – YFV (Chip Scale, DSBGA) Package

| Table 7-3. Signal Descriptions – YFV Package | | | | |
|--|-----|--------------------|---|--|
| NAME | NO. | TYPE | DESCRIPTION | |
| DCDC_SW | D1 | Power | Output from internal DC/DC ⁽¹⁾ | |
| DCOUPL | F3 | Power | 1.27-V regulated digital-supply decoupling ⁽²⁾ | |
| DIO_0 | C5 | Digital I/O | GPIO, Sensor Controller | |
| DIO_1 | F6 | Digital I/O | GPIO, Sensor Controller | |
| DIO_2 | D5 | Digital I/O | GPIO, Sensor Controller, high-drive capability | |
| DIO_3 | E5 | Digital I/O | GPIO, Sensor Controller, high-drive capability | |
| DIO_4 | F5 | Digital I/O | GPIO, Sensor Controller, high-drive capability | |
| DIO_5 | E3 | Digital I/O | GPIO, High-drive capability, JTAG_TDO | |
| DIO_6 | F1 | Digital I/O | GPIO, High-drive capability, JTAG_TDI | |
| DIO_7 | D2 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_8 | D3 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_9 | A1 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_10 | C2 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_11 | B2 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_12 | D4 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| DIO_13 | B3 | Digital/Analog I/O | GPIO, Sensor Controller, Analog | |
| JTAG_TMSC | E4 | Digital I/O | JTAG TMSC, high-drive capability | |
| JTAG_TCKC | F2 | Digital I/O | JTAG TCKC ⁽³⁾ | |
| RESET_N | E2 | Digital input | Reset, active-low. No internal pullup. | |

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| Table 7-3. Signal Descriptions – YFV Package (continued) | | | | |
|--|-------------------|------------|--|--|
| NAME | NO. | TYPE | DESCRIPTION | |
| RF_N | B6 | RF I/O | Negative RF input signal to LNA during RX Negative RF output signal to PA during TX | |
| RF_P | B5 | RF I/O | Positive RF input signal to LNA during RX Positive RF output signal to PA during TX | |
| VDDR | A3 | Power | 1.7-V to 1.95-V supply, typically connect to output of internal DC/DC ⁽⁴⁾ (2) | |
| VDDR_RF | B4 | Power | 1.7-V to 1.95-V supply, typically connect to output of internal DC/DC ⁽⁵⁾ (2) | |
| VDDS | A2 | Power | 1.8-V to 3.8-V main chip supply ⁽¹⁾ | |
| VDDS2 | F4 | Power | 1.8-V to 3.8-V GPIO supply ⁽¹⁾ | |
| VDDS_DCDC | C1 | Power | 1.8-V to 3.8-V DC/DC supply | |
| X32K_Q1 | D6 | Analog I/O | 32-kHz crystal oscillator pin 1 | |
| X32K_Q2 | E6 | Analog I/O | 32-kHz crystal oscillator pin 2 | |
| X24M_N | C3 | Analog I/O | 24-MHz crystal oscillator pin 1 | |
| X24M_P | C4 | Analog I/O | 24-MHz crystal oscillator pin 2 | |
| GND | A4, B1, C6, E1 | Power | Ground | |

(1) For more details, see the technical reference manual (listed in Section 11.3).

(2) Do not supply external circuitry from this pin.

(3) For design consideration regarding noise immunity for this pin, see the JTAG Interface chapter in the CC13x0, CC26x0 SimpleLink™ Wireless MCU Technical Reference Manual

(4) If internal DC/DC is not used, this pin is supplied internally from the main LDO.

(5) If internal DC/DC is not used, this pin must be connected to VDDR for supply from the main LDO.



7.7 Pin Diagram – RSM Package

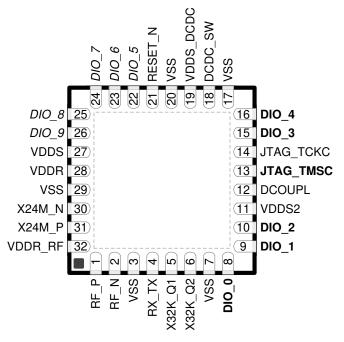


Figure 7-4. RSM Package 32-Pin VQFN (4-mm × 4-mm) Pinout, 0.4-mm Pitch

I/O pins marked in Figure 7-4 in **bold** have high-drive capabilities; they are as follows:

- Pin 8, DIO_0
- Pin 9, DIO_1
- Pin 10, DIO 2
- Pin 13, JTAG_TMSC
- Pin 15, DIO_3
- Pin 16, DIO_4

I/O pins marked in Figure 7-4 in *italics* have analog capabilities; they are as follows:

- Pin 22, DIO_5
- Pin 23, DIO_6
- Pin 24, DIO_7
- Pin 25, DIO_8
- Pin 26, DIO_9



7.8 Signal Descriptions – RSM Package

Table 7-4. Signal Descriptions – RSM Package

| NAME | NO. | TYPE | DESCRIPTION |
|-----------|---------------------|--------------------|--|
| DCDC_SW | 18 | Power | Output from internal DC/DC. ⁽¹⁾ . Tie to ground for external regulator mode (1.7-V to 1.95-V operation) |
| DCOUPL | 12 | Power | 1.27-V regulated digital-supply decoupling capacitor ⁽²⁾ |
| DIO_0 | 8 | Digital I/O | GPIO, Sensor Controller, high-drive capability |
| DIO_1 | 9 | Digital I/O | GPIO, Sensor Controller, high-drive capability |
| DIO_2 | 10 | Digital I/O | GPIO, Sensor Controller, high-drive capability |
| DIO_3 | 15 | Digital I/O | GPIO, High-drive capability, JTAG_TDO |
| DIO_4 | 16 | Digital I/O | GPIO, High-drive capability, JTAG_TDI |
| DIO_5 | 22 | Digital/Analog I/O | GPIO, Sensor Controller, Analog |
| DIO_6 | 23 | Digital/Analog I/O | GPIO, Sensor Controller, Analog |
| DIO_7 | 24 | Digital/Analog I/O | GPIO, Sensor Controller, Analog |
| DIO_8 | 25 | Digital/Analog I/O | GPIO, Sensor Controller, Analog |
| DIO_9 | 26 | Digital/Analog I/O | GPIO, Sensor Controller, Analog |
| JTAG_TMSC | 13 | Digital I/O | JTAG TMSC |
| JTAG_TCKC | 14 | Digital I/O | JTAG TCKC ⁽³⁾ |
| RESET_N | 21 | Digital Input | Reset, active-low. No internal pullup. |
| RF_N | 2 | RF I/O | Negative RF input signal to LNA during RX Negative RF output signal to PA during TX |
| RF_P | 1 | RF I/O | Positive RF input signal to LNA during RX Positive RF output signal to PA during TX |
| RX_TX | 4 | RF I/O | Optional bias pin for the RF LNA |
| VDDR | 28 | Power | 1.7-V to 1.95-V supply, typically connect to output of internal DC/DC. ^{(2) (4)} |
| VDDR_RF | 32 | Power | 1.7-V to 1.95-V supply, typically connect to output of internal DC/DC ^{(2) (5)} |
| VDDS | 27 | Power | 1.8-V to 3.8-V main chip supply ⁽¹⁾ |
| VDDS2 | 11 | Power | 1.8-V to 3.8-V GPIO supply ⁽¹⁾ |
| VDDS_DCDC | 19 | Power | 1.8-V to 3.8-V DC/DC supply. Tie to ground for external regulator mode (1.7-V to 1.95-V operation). |
| VSS | 3, 7, 17, 20, 29 | Power | Ground |
| X32K_Q1 | 5 | Analog I/O | 32-kHz crystal oscillator pin 1 |
| X32K_Q2 | 6 | Analog I/O | 32-kHz crystal oscillator pin 2 |
| X24M_N | 30 | Analog I/O | 24-MHz crystal oscillator pin 1 |
| X24M_P | 31 | Analog I/O | 24-MHz crystal oscillator pin 2 |
| EGP | | Power | Ground – Exposed Ground Pad |

(1) See technical reference manual (listed in Section 11.3) for more details.

(2) Do not supply external circuitry from this pin.

(3) For design consideration regarding noise immunity for this pin, see the JTAG Interface chapter in the CC13x0, CC26x0 SimpleLink[™] Wireless MCU Technical Reference Manual

(4) If internal DC/DC is not used, this pin is supplied internally from the main LDO.

(5) If internal DC/DC is not used, this pin must be connected to VDDR for supply from the main LDO.



8 Specifications

8.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)^{(1) (2)}

| | | MIN | MAX | UNIT |
|---|--|------|----------------------|------|
| Supply voltage (VDDS, VDDS2, and VDDS3) | VDDR supplied by internal DC/DC regulator or internal GLDO. VDDS_DCDC connected to VDDS on PCB | -0.3 | 4.1 | V |
| Supply voltage (VDDS ⁽³⁾ and VDDR) | External regulator mode (VDDS and VDDR pins connected on PCB) | -0.3 | 2.25 | V |
| Voltage on any digital pin ^{(4) (5)} | | | VDDSx + 0.3, max 4.1 | V |
| Voltage on crystal oscillator pins, X | K32K_Q1, X32K_Q2, X24M_N and X24M_P | -0.3 | VDDR + 0.3, max 2.25 | V |
| | Voltage scaling enabled | -0.3 | VDDS | |
| Voltage on ADC input (V _{in}) | Voltage scaling disabled, internal reference | -0.3 | 1.49 | V |
| | Voltage scaling disabled, VDDS as reference | -0.3 | VDDS / 2.9 | |
| Input RF level | | | 5 | dBm |
| T _{stg} | Storage temperature | -40 | 150 | °C |

(1) All voltage values are with respect to ground, unless otherwise noted.

(2) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(3) In external regulator mode, VDDS2 and VDDS3 must be at the same potential as VDDS.

(4) Including analog-capable DIO.

(5) Each pin is referenced to a specific VDDSx (VDDS, VDDS2 or VDDS3). For a pin-to-VDDS mapping table, see Table 9-3.

8.2 ESD Ratings

| | | | | VALUE | UNIT | |
|----------------------------|--|--|-------------|-------|------|--|
| | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/ JEDEC JS001 ⁽¹⁾ | All pins | ±2500 | | |
| VESD | V _{ESD} RSM, RHB, and RGZ packages | Charged device model (CDM), per JESD22- | RF pins | ±500 | V | |
| | · · · · · · · · · · · · · · · · · · · | C101 ⁽²⁾ | Non-RF pins | ±500 | | |
| Electrostatic discharge | | Human body model (HBM), per ANSI/ESDA/ JEDEC JS001 ⁽¹⁾ | All pins | ±1500 | | |
| V _{ESD} YFV pa | YFV package | Charged device model (CDM), per JESD22- | RF pins | ±500 | V | |
| | | C101 ⁽²⁾ | Non-RF pins | ±500 | | |

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



8.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| | | | MIN | MAX | UNIT |
|--|--|--------------|-----|------|------|
| Ambient temperature | | -40 | 85 | °C | |
| Operating supply voltage (VDDS and VDDR), external regulator mode | For operation in 1.8-V systems (VDDS and VDDR pins connected on PCB, internal DC/DC cannot be used) | | 1.7 | 1.95 | v |
| Operating supply voltage VDDS | (internal DC/DC can be used to minimize power consumption) | | 1.8 | 3.8 | V |
| Operating supply voltages VDDS2 and VDDS3 | | VDDS < 2.7 V | 1.8 | 3.8 | V |
| Operating supply voltages VDDS2 and VDDS3 | | VDDS ≥ 2.7 V | 1.9 | 3.8 | V |

8.4 Power Consumption Summary

Measured on the TI CC2650EM-5XD reference design with $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V with internal DC/DC converter, unless otherwise noted.

| | PARAMETER | TEST CONDITIONS | MIN TYP | MAX | UNIT |
|--|---|---|---|-----|------|
| | | Reset. RESET_N pin asserted or VDDS below Power-on-Reset threshold | 100 | | nA |
| | Core current consumption Core current consumption Peripheral Current Consumption (Peripheral power domain Serial power domain RF Core µDMA Timers I²C I2S SSI | Shutdown. No clocks running, no retention | 150 | | |
| | | Standby. With RTC, CPU, RAM and (partial) register retention. RCOSC_LF | 1.1 | | |
| I _{core} Core current consumption | Standby. With RTC, CPU, RAM and (partial) register retention. XOSC_LF | 1.3 | | | |
| | | Standby. With Cache, RTC, CPU, RAM and (partial) register retention. RCOSC_LF | 2.8 | | μA |
| | Standby. With Cache, RTC, CPU, RAM and (partial) register retention. XOSC_LF | 3.0 | | | |
| | | Idle. Supply Systems and RAM powered. | $ \begin{array}{ c c c c } eq:set_set_set_set_set_set_set_set_set_set_$ | | |
| | | Active. Core running CoreMark | - | | |
| | | Radio RX ⁽¹⁾ | 5.9 | | |
| | | Radio RX ⁽²⁾ | 6.1 | | |
| | | Radio TX, 0-dBm output power ⁽¹⁾ | 6.1 | | mA |
| | | Radio TX, 5-dBm output power ⁽²⁾ | 9.1 | | |
| Periph | neral Current Consumption (A | Adds to core current I _{core} for each peripheral unit a | activated) ⁽³⁾ | | |
| | Peripheral power domain | Delta current with domain enabled | 50 | | μA |
| | Serial power domain | Delta current with domain enabled | 13 | | μA |
| | RF Core | Delta current with power domain enabled, clock enabled, RF core idle | 237 | | μA |
| | μDMA | Delta current with clock enabled, module idle | 130 | | μA |
| peri | Timers | Delta current with clock enabled, module idle | 113 | | μA |
| | l ² C | Delta current with clock enabled, module idle | 12 | | μA |
| | I2S | Delta current with clock enabled, module idle | 36 | | μA |
| | SSI | Delta current with clock enabled, module idle | 93 | | μA |
| | UART | Delta current with clock enabled, module idle | 164 | | μA |

(1) Single-ended RF mode is optimized for size and power consumption. Measured on CC2650EM-4XS.

(2) Differential RF mode is optimized for RF performance. Measured on CC2650EM-5XD.



(3) I_{peri} is not supported in Standby or Shutdown.

8.5 General Characteristics

 $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|--|------|------|-----|---------------------|
| FLASH MEMORY | · · · | | | | |
| Supported flash erase cycles before failure ⁽¹⁾ | | 100 | | | k Cycles |
| Maximum number of write operations per row before erase ⁽²⁾ | | | | 83 | write operations |
| Flash retention | 105°C | 11.4 | | | Years at 105°C |
| Flash page/sector erase current | Average delta current | | 12.6 | | mA |
| Flash page/sector size | | | 4 | | KB |
| Flash write current | Average delta current, 4 bytes at a time | | 8.15 | | mA |
| Flash page/sector erase time ⁽³⁾ | | | 8 | | ms |
| Flash write time ⁽³⁾ | 4 bytes at a time | | 8 | | μs |

(1) Aborting flash during erase or program modes is not a safe operation.

(2) Each row is 2048 bits (or 256 Bytes) wide.

(3) This number is dependent on Flash aging and will increase over time and erase cycles.

8.6 125-kbps Coded (Bluetooth 5) - RX

Measured on the TI CC2650EM-5XD reference design with T_c = 25°C, V_{DDS} = 3.0 V, f_{RF} = 2440 MHz, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|--|------|------------------------|-----|------|
| Receiver sensitivity | Differential mode. Measured at the CC2650EM-5XD SMA connector, BER = 10^{-3} | | -103 | | dBm |
| Receiver saturation | Differential mode. Measured at the CC2650EM-5XD SMA connector, BER = 10^{-3} | | >5 | | dBm |
| Frequency error tolerance | Difference between the incoming carrier frequency and the internally generated carrier frequency | -260 | | 310 | kHz |
| Data rate error tolerance | Difference between incoming data rate and the internally generated data rate (37-byte packets) | -260 | | 260 | ppm |
| Data rate error tolerance | Difference between incoming data rate and the internally generated data rate (255-byte packets) | -140 | | 140 | ppm |
| Co-channel rejection ⁽¹⁾ | Wanted signal at –79 dBm, modulated interferer in channel, BER = 10^{-3} | | -3 | | dB |
| Selectivity, ±1 MHz ⁽¹⁾ | Wanted signal at –79 dBm, modulated interferer at ±1 MHz, BER = 10^{-3} | | 9 / 5 ⁽²⁾ | | dB |
| Selectivity, ±2 MHz ⁽¹⁾ | Wanted signal at –79 dBm, modulated interferer at ± 2 MHz, Image frequency is at –2 MHz, BER = 10^{-3} | | 43 / 32 ⁽²⁾ | | dB |
| Selectivity, ±3 MHz ⁽¹⁾ | Wanted signal at –79 dBm, modulated interferer at ±3 MHz, BER = 10^{-3} | | 47 / 42 ⁽²⁾ | | dB |
| Selectivity, ±4 MHz ⁽¹⁾ | Wanted signal at –79 dBm, modulated interferer at ±4 MHz, BER = 10^{-3} | | 46 / 47 ⁽²⁾ | | dB |
| Selectivity, ±6 MHz ⁽¹⁾ | Wanted signal at –79 dBm, modulated interferer at ± 6 MHz, BER = 10^{-3} | | 49 / 46 ⁽²⁾ | | dB |
| Alternate channel rejection, ±7 MHz ⁽¹⁾ | Wanted signal at –79 dBm, modulated interferer at \ge ±7 MHz, BER = 10 ⁻³ | | 50 / 47 ⁽²⁾ | | dB |
| Selectivity, image frequency ⁽¹⁾ | Wanted signal at -79 dBm, modulated interferer at image frequency, BER = 10^{-3} | | 32 | | dB |



Measured on the TI CC2650EM-5XD reference design with $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, $f_{RF} = 2440$ MHz, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|-----|-----------------------|-----|------|
| Selectivity, image frequency ±1 MHz ⁽¹⁾ | Note that Image frequency + 1 MHz is the Co-channel -1 MHz. Wanted signal at -79 dBm, modulated interferer at ± 1 MHz from image frequency, BER = 10^{-3} | | 5 / 32 ⁽²⁾ | | dB |
| Blocker rejection, ±8 MHz and above ⁽¹⁾ | Wanted signal at –79 dBm, modulated interferer at ± 8 MHz and above, BER = 10^{-3} | | >46 | | dB |
| Out-of-band blocking ⁽³⁾ | 30 MHz to 2000 MHz | | -40 | | dBm |
| Out-of-band blocking | 2003 MHz to 2399 MHz | | -19 | | dBm |
| Out-of-band blocking | 2484 MHz to 2997 MHz | | -22 | | dBm |
| Intermodulation | Wanted signal at 2402 MHz, –76 dBm. Two interferers at 2405 and 2408 MHz respectively, at the given power level | | -42 | | dBm |

(1) Numbers given as I/C dB.

(2) X / Y, where X is +N MHz and Y is –N MHz.

(3) Excluding one exception at F_{wanted} / 2, per Bluetooth Specification.

8.7 125-kbps Coded (Bluetooth 5) – TX

Measured on the TI CC2650EM-5XD reference design with $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, $f_{RF} = 2440$ MHz, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------------------|--|-----|-----|-----|------|
| Output power, highest setting | Differential mode, delivered to a single-ended 50- Ω load through a balun | | 5 | | dBm |
| Output power, highest setting | Measured on CC2650EM-4XS, delivered to a single-ended 50 - Ω load | | 2 | | dBm |
| Output power, lowest setting | Delivered to a single-ended 50- Ω load through a balun | | -21 | | dBm |
| | f < 1 GHz, outside restricted bands | | -43 | | dBm |
| Spurious emission conducted | f < 1 GHz, restricted bands ETSI | | -65 | | dBm |
| measurement ⁽¹⁾ | f < 1 GHz, restricted bands FCC | | -71 | | dBm |
| | f > 1 GHz, including harmonics | | -46 | | dBm |

(1) Suitable for systems targeting compliance with worldwide radio-frequency regulations ETSI EN 300 328 and EN 300 440 Class 2 (Europe), FCC CFR47 Part 15 (US), and ARIB STD-T66 (Japan).

8.8 500-kbps Coded (Bluetooth 5) - RX

Measured on the TI CC2650EM-5XD reference design with $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, $f_{RF} = 2440$ MHz, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------------------------|---|------|----------------------|-----|------|
| Receiver sensitivity | Differential mode. Measured at the CC2650EM-5XD SMA connector, BER = 10^{-3} | | -101 | | dBm |
| Receiver saturation | Differential mode. Measured at the CC2650EM-5XD SMA connector, BER = 10^{-3} | | >5 | | dBm |
| Frequency error tolerance | Difference between the incoming carrier frequency and the internally generated carrier frequency | -240 | | 240 | kHz |
| Data rate error tolerance | Difference between incoming data rate and the internally generated data rate (37-byte packets) | -500 | | 500 | ppm |
| Data rate error tolerance | Difference between incoming data rate and the internally generated data rate (255-byte packets) | -310 | | 330 | ppm |
| Co-channel rejection ⁽¹⁾ | Wanted signal at -72 dBm, modulated interferer in channel, BER = 10^{-3} | | -5 | | dB |
| Selectivity, ±1 MHz ⁽¹⁾ | Wanted signal at –72 dBm, modulated interferer at ±1 MHz, BER = 10^{-3} | | 9 / 5 ⁽²⁾ | | dB |



Measured on the TI CC2650EM-5XD reference design with T_c = 25°C, V_{DDS} = 3.0 V, f_{RF} = 2440 MHz, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN TYP MAX | UNIT |
|---|---|------------------------|------|
| Selectivity, ±2 MHz ⁽¹⁾ | Wanted signal at –72 dBm, modulated interferer at ± 2 MHz, Image frequency is at –2 MHz, BER = 10^{-3} | 41 / 31 ⁽²⁾ | dB |
| Selectivity, ±3 MHz ⁽¹⁾ | Wanted signal at –72 dBm, modulated interferer at ± 3 MHz, BER = 10^{-3} | 44 / 41 ⁽²⁾ | dB |
| Selectivity, ±4 MHz ⁽¹⁾ | Wanted signal at –72 dBm, modulated interferer at ±4 MHz, BER = 10^{-3} | 44 / 44 ⁽²⁾ | dB |
| Selectivity, ±6 MHz ⁽¹⁾ | Wanted signal at –72 dBm, modulated interferer at ± 6 MHz, BER = 10^{-3} | 44 / 44 ⁽²⁾ | dB |
| Alternate channel rejection, ±7 MHz ⁽¹⁾ | Wanted signal at –72 dBm, modulated interferer at $\ge \pm 7$ MHz, BER = 10^{-3} | 44 / 44 ⁽²⁾ | dB |
| Selectivity, image frequency ⁽¹⁾ | Wanted signal at -72 dBm, modulated interferer at image frequency, BER = 10^{-3} | 31 | dB |
| Selectivity, image frequency ±1 MHz ⁽¹⁾ | Note that Image frequency + 1 MHz is the Co-channel -1 MHz. Wanted signal at -72 dBm, modulated interferer at ± 1 MHz from image frequency, BER = 10^{-3} | 5 / 41 ⁽²⁾ | dB |
| Blocker rejection, ±8 MHz and above ⁽¹⁾ | Wanted signal at –72 dBm, modulated interferer at ± 8 MHz and above, BER = 10^{-3} | 44 | dB |
| Out-of-band blocking ⁽³⁾ | 30 MHz to 2000 MHz | -35 | dBm |
| Out-of-band blocking | 2003 MHz to 2399 MHz | -19 | dBm |
| Out-of-band blocking | 2484 MHz to 2997 MHz | -19 | dBm |
| Intermodulation | Wanted signal at 2402 MHz, –69 dBm. Two interferers at 2405 and 2408 MHz respectively, at the given power level | -37 | dBm |

(1) Numbers given as I/C dB.

(2) X / Y, where X is +N MHz and Y is –N MHz.

(3) Excluding one exception at F_{wanted} / 2, per Bluetooth Specification.

8.9 500-kbps Coded (Bluetooth 5) – TX

| Measured on the TI CC2650EM-5XD reference design with $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, $f_{RF} = 2440$ MHz, unless | , |
|--|---|
| otherwise noted. | |

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------------------|--|-----|-----|-----|------|
| Output power, highest setting | Differential mode, delivered to a single-ended 50- Ω load through a balun | | 5 | | dBm |
| Output power, highest setting | Measured on CC2650EM-4XS, delivered to a single-ended 50 - Ω load | 2 | | | dBm |
| Output power, lowest setting | Delivered to a single-ended 50- Ω load through a balun | -21 | | | dBm |
| | f < 1 GHz, outside restricted bands | | -43 | | dBm |
| Spurious emission conducted | f < 1 GHz, restricted bands ETSI | | -65 | | dBm |
| measurement ⁽¹⁾ | f < 1 GHz, restricted bands FCC | | -71 | | dBm |
| | f > 1 GHz, including harmonics | | -46 | | dBm |

(1) Suitable for systems targeting compliance with worldwide radio-frequency regulations ETSI EN 300 328 and EN 300 440 Class 2 (Europe), FCC CFR47 Part 15 (US), and ARIB STD-T66 (Japan).



8.10 1-Mbps GFSK (Bluetooth low energy) – RX

Measured on the TI CC2650EM-5XD reference design with T_c = 25°C, V_{DDS} = 3.0 V, f_{RF} = 2440 MHz, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|--|------|------------------------|-----|------|
| Receiver sensitivity | Differential mode. Measured at the CC2650EM-5XD SMA connector, BER = 10^{-3} | | -97 | | dBm |
| Receiver sensitivity | Single-ended mode. Measured on CC2650EM-4XS, at the SMA connector, BER = 10^{-3} | | -96 | | dBm |
| Receiver saturation | Differential mode. Measured at the CC2650EM-5XD SMA connector, BER = 10^{-3} | | 4 | | dBm |
| Receiver saturation | Single-ended mode. Measured on CC2650EM-4XS, at the SMA connector, BER = 10^{-3} | | 0 | | dBm |
| Frequency error tolerance | Difference between the incoming carrier frequency and the internally generated carrier frequency | -350 | | 350 | kHz |
| Data rate error tolerance | Difference between incoming data rate and the internally generated data rate | -750 | | 750 | ppm |
| Co-channel rejection ⁽¹⁾ | Wanted signal at –67 dBm, modulated interferer in channel, BER = 10^{-3} | | -6 | | dB |
| Selectivity, ±1 MHz ⁽¹⁾ | Wanted signal at -67 dBm, modulated interferer at ± 1 MHz, BER = 10^{-3} | | 7 / 3 ⁽²⁾ | | dB |
| Selectivity, ±2 MHz ⁽¹⁾ | Wanted signal at -67 dBm, modulated interferer at ± 2 MHz, BER = 10^{-3} | | 34 / 25 ⁽²⁾ | | dB |
| Selectivity, ±3 MHz ⁽¹⁾ | Wanted signal at -67 dBm, modulated interferer at ± 3 MHz, BER = 10^{-3} | | 38 / 26 ⁽²⁾ | | dB |
| Selectivity, ±4 MHz ⁽¹⁾ | Wanted signal at -67 dBm, modulated interferer at ± 4 MHz, BER = 10^{-3} | | 42 / 29 ⁽²⁾ | | dB |
| Selectivity, ±5 MHz or more ⁽¹⁾ | Wanted signal at –67 dBm, modulated interferer at $\ge \pm 5$ MHz, BER = 10^{-3} | | 32 | | dB |
| Selectivity, image frequency ⁽¹⁾ | Wanted signal at -67 dBm, modulated interferer at image frequency, BER = 10^{-3} | | 25 | | dB |
| Selectivity, image frequency ±1 MHz ⁽¹⁾ | Wanted signal at -67 dBm, modulated interferer at ± 1 MHz from image frequency, BER = 10^{-3} | | 3 / 26 ⁽²⁾ | | dB |
| Out-of-band blocking ⁽³⁾ | 30 MHz to 2000 MHz | | -20 | | dBm |
| Out-of-band blocking | 2003 MHz to 2399 MHz | | -5 | | dBm |
| Out-of-band blocking | 2484 MHz to 2997 MHz | | -8 | | dBm |
| Out-of-band blocking | 3000 MHz to 12.75 GHz | | -10 | | dBm |
| Intermodulation | Wanted signal at 2402 MHz, –64 dBm. Two interferers at 2405 and 2408 MHz respectively, at the given power level | | -34 | | dBm |
| Spurious emissions, 30 to 1000 MHz | Conducted measurement in a $50-\Omega$ single-ended load. Suitable for systems targeting compliance with EN 300 328, EN 300 440 class 2, FCC CFR47, Part 15 and ARIB STD-T-66 | | -71 | | dBm |
| Spurious emissions, 1 to 12.75 GHz | Conducted measurement in a $50-\Omega$ single-ended load. Suitable for systems targeting compliance with EN 300 328, EN 300 440 class 2, FCC CFR47, Part 15 and ARIB STD-T-66 | | -62 | | dBm |
| RSSI dynamic range | | | 70 | | dB |
| RSSI accuracy | | | ±4 | | dB |

(1) Numbers given as I/C dB.

(2) X / Y, where X is +N MHz and Y is –N MHz.

(3) Excluding one exception at F_{wanted} / 2, per Bluetooth Specification.



8.11 1-Mbps GFSK (Bluetooth low energy) – TX

Measured on the TI CC2650EM-5XD reference design with $T_c = 25^{\circ}C$, $V_{DDS} = 3.0 \text{ V}$, $f_{RF} = 2440 \text{ MHz}$, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT | |
|-------------------------------|--|-----|-----|-----|------|--|
| Output power, highest setting | Differential mode, delivered to a single-ended 50- Ω load through a balun | | 5 | | dBm | |
| Output power, highest setting | Measured on CC2650EM-4XS, delivered to a single-ended 50- Ω load | | 2 | | dBm | |
| Output power, lowest setting | Delivered to a single-ended 50- Ω load through a balun | | -21 | | dBm | |
| | f < 1 GHz, outside restricted bands | | -43 | | dBm | |
| Spurious emission conducted | f < 1 GHz, restricted bands ETSI | | -65 | | dBm | |
| measurement ⁽¹⁾ | f < 1 GHz, restricted bands FCC | | -71 | | dBm | |
| | f > 1 GHz, including harmonics | | -46 | | dBm | |

(1) Suitable for systems targeting compliance with worldwide radio-frequency regulations ETSI EN 300 328 and EN 300 440 Class 2 (Europe), FCC CFR47 Part 15 (US), and ARIB STD-T66 (Japan).

8.12 2-Mbps GFSK (Bluetooth 5) – RX

Measured on the TI CC2650EM-5XD reference design with T_c = 25°C, V_{DDS} = 3.0 V, f_{RF} = 2440 MHz, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | ТҮР | MAX | UNIT |
|---|---|-------|------------------------|------|------|
| Receiver sensitivity | Differential mode. Measured at the CC2650EM-5XD SMA connector, BER = 10^{-3} | | -91 | | dBm |
| Receiver saturation | Differential mode. Measured at the CC2650EM-5XD SMA connector, BER = 10^{-3} | | 3 | | dBm |
| Frequency error tolerance | Difference between the incoming carrier frequency and the internally generated carrier frequency | -300 | | 500 | kHz |
| Data rate error tolerance | Difference between incoming data rate and the internally generated data rate | -1000 | | 1000 | ppm |
| Co-channel rejection ⁽¹⁾ | Wanted signal at -67 dBm, modulated interferer in channel, BER = 10^{-3} | | -7 | | dB |
| Selectivity, ±2 MHz ⁽¹⁾ | Wanted signal at –67 dBm, modulated interferer at ± 2 MHz, Image frequency is at –2 MHz BER = 10^{-3} | | 8 / 4 ⁽²⁾ | | dB |
| Selectivity, ±4 MHz ⁽¹⁾ | Wanted signal at –67 dBm, modulated interferer at ± 4 MHz, BER = 10^{-3} | | 31 / 26 ⁽²⁾ | | dB |
| Selectivity, ±6 MHz ⁽¹⁾ | Wanted signal at –67 dBm, modulated interferer at ± 6 MHz, BER = 10^{-3} | | 37 / 38 ⁽²⁾ | | dB |
| Alternate channel rejection, ±7 MHz ⁽¹⁾ | Wanted signal at –67 dBm, modulated interferer at $\ge \pm 7$ MHz, BER = 10^{-3} | | 37 / 36 ⁽²⁾ | | dB |
| Selectivity, image frequency ⁽¹⁾ | Wanted signal at -67 dBm, modulated interferer at image frequency, BER = 10^{-3} | | 4 | | dB |
| Selectivity, image frequency ±2 MHz ⁽¹⁾ | Note that Image frequency + 2 MHz is the Co-channel. Wanted signal at -67 dBm, modulated interferer at ± 2 MHz from image frequency, BER = 10^{-3} | | -7 / 26 ⁽²⁾ | | dB |
| Out-of-band blocking ⁽³⁾ | 30 MHz to 2000 MHz | | -33 | | dBm |
| Out-of-band blocking | 2003 MHz to 2399 MHz | | -15 | | dBm |
| Out-of-band blocking | 2484 MHz to 2997 MHz | | -12 | | dBm |
| Out-of-band blocking | 3000 MHz to 12.75 GHz | | -10 | | dBm |
| Intermodulation | Wanted signal at 2402 MHz, –64 dBm. Two interferers at 2408 and 2414 MHz respectively, at the given power level | | -45 | | dBm |

(1) Numbers given as I/C dB.

(2) X / Y, where X is +N MHz and Y is –N MHz.

(3) Excluding one exception at F_{wanted} / 2, per Bluetooth Specification.

8.13 2-Mbps GFSK (Bluetooth 5) - TX

Measured on the TI CC2650EM-5XD reference design with $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, $f_{RF} = 2440$ MHz, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | ТҮР | MAX | UNIT |
|-------------------------------|--|------|-----|-----|------|
| Output power, highest setting | Differential mode, delivered to a single-ended 50- Ω load through a balun | ad 5 | | | dBm |
| Output power, highest setting | Measured on CC2650EM-4XS, delivered to a single-ended 50 - Ω load | | 2 | | dBm |
| Output power, lowest setting | Delivered to a single-ended 50- Ω load through a balun | -21 | | | dBm |
| | f < 1 GHz, outside restricted bands | | -43 | | dBm |
| Spurious emission conducted | f < 1 GHz, restricted bands ETSI | | -65 | | dBm |
| measurement ⁽¹⁾ | f < 1 GHz, restricted bands FCC | | -71 | | dBm |
| | f > 1 GHz, including harmonics | | -46 | | dBm |

(1) Suitable for systems targeting compliance with worldwide radio-frequency regulations ETSI EN 300 328 and EN 300 440 Class 2 (Europe), FCC CFR47 Part 15 (US), and ARIB STD-T66 (Japan).

8.14 24-MHz Crystal Oscillator (XOSC_HF)

 $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, unless otherwise noted.⁽¹⁾

| PARAMETER | TEST CONDITIONS | MIN | ТҮР | MAX | UNIT |
|--|---|-----|---|-----|------|
| ESR Equivalent series resistance ⁽²⁾ | 6 pF < C _L ≤ 9 pF | | 20 | 60 | Ω |
| ESR Equivalent series resistance ⁽²⁾ | 5 pF < C _L ≤ 6 pF | | | 80 | Ω |
| L _M Motional inductance ⁽²⁾ | Relates to load capacitance $(C_L \text{ in Farads})$ | | < 1.6 × 10 ⁻²⁴ / C _L ² | | н |
| C _L Crystal load capacitance ^{(2) (3)} | | 5 | | 9 | pF |
| Crystal frequency ^{(2) (4)} | | | 24 | | MHz |
| Crystal frequency tolerance ^{(2) (5)} | | -40 | | 40 | ppm |
| Start-up time ^{(4) (6)} | | | 150 | | μs |

(1) Probing or otherwise stopping the crystal while the DC/DC converter is enabled may cause permanent damage to the device.

(2) The crystal manufacturer's specification must satisfy this requirement

(3) Adjustable load capacitance is integrated into the device. External load capacitors are not required

(4) Measured on the TI CC2650EM-5XD reference design with $T_c = 25^{\circ}C$, $V_{DDS} = 3.0 V$

(5) Includes initial tolerance of the crystal, drift over temperature, ageing and frequency pulling due to incorrect load capacitance. As per specification.

(6) Kick-started based on a temperature and aging compensated RCOSC_HF using precharge injection.

8.15 32.768-kHz Crystal Oscillator (XOSC_LF)

 $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|-----------------|------|--------|-----|------|
| Crystal frequency ⁽¹⁾ | | | 32.768 | | kHz |
| Crystal frequency tolerance, Bluetooth low- energy applications ⁽¹⁾ ⁽²⁾ | | -500 | | 500 | ppm |
| ESR Equivalent series resistance ⁽¹⁾ | | | 30 | 100 | kΩ |
| C _L Crystal load capacitance ⁽¹⁾ | | 6 | | 12 | pF |

(1) The crystal manufacturer's specification must satisfy this requirement

(2) Includes initial tolerance of the crystal, drift over temperature, ageing and frequency pulling due to incorrect load capacitance. As per Bluetooth specification.



8.16 48-MHz RC Oscillator (RCOSC_HF)

Measured on the TI CC2650EM-5XD reference design with $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|-----------------|-----|--------|-----|------|
| Frequency | | | 48 | | MHz |
| Uncalibrated frequency accuracy | | | ±1% | | |
| Calibrated frequency accuracy ⁽¹⁾ | | | ±0.25% | | |
| Start-up time | | | 5 | | μs |

(1) Accuracy relative to the calibration source (XOSC_HF).

8.17 32-kHz RC Oscillator (RCOSC_LF)

Measured on the TI CC2650EM-5XD reference design with T_c = 25°C, V_{DDS} = 3.0 V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------------------------|-----------------|-----|------|-----|--------|
| Calibrated frequency ⁽¹⁾ | | | 32.8 | | kHz |
| Temperature coefficient | | | 80 | | ppm/°C |

(1) The frequency accuracy of the Real Time Clock (RTC) is not directly dependent on the frequency accuracy of the 32-kHz RC Oscillator. The RTC can be calibrated to an accuracy within ±500 ppm of 32.768 kHz by measuring the frequency error of RCOSC_LF relative to XOSC_HF and compensating the RTC tick speed. The procedure is explained in *Running Bluetooth*® *Low Energy on CC2640 Without 32 kHz Crystal*.

8.18 ADC Characteristics

 $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V and voltage scaling enabled, unless otherwise noted.⁽¹⁾

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--------------------|--------------------------------|---|-----|------|------|------|
| | Input voltage range | | 0 | | VDDS | V |
| | Resolution | | | 12 | | Bits |
| | Sample rate | | | | 200 | ksps |
| | Offset | Internal 4.3-V equivalent reference ⁽²⁾ | | 2 | | LSB |
| | Gain error | Internal 4.3-V equivalent reference ⁽²⁾ | | 2.4 | | LSB |
| DNL ⁽³⁾ | Differential nonlinearity | | | >–1 | | LSB |
| INL ⁽⁴⁾ | Integral nonlinearity | | | ±3 | | LSB |
| | | Internal 4.3-V equivalent reference ⁽²⁾ , 200 ksps, 9.6-kHz input tone | | 9.8 | | |
| ENOB | Effective number of bits | VDDS as reference, 200 ksps, 9.6-kHz input tone | | 10 | | Bits |
| | | Internal 1.44-V reference, voltage scaling disabled, 32 samples average, 200 ksps, 300-Hz input tone | | 11.1 | | |
| | Total harmonic distortion | Internal 4.3-V equivalent reference ⁽²⁾ , 200 ksps, 9.6-kHz input tone | | -65 | | |
| THD | | VDDS as reference, 200 ksps, 9.6-kHz input tone | | -69 | | dB |
| | | Internal 1.44-V reference, voltage scaling disabled, 32 samples average, 200 ksps, 300-Hz input tone | | -71 | | |
| | Signal-to-noise | Internal 4.3-V equivalent reference ⁽²⁾ , 200 ksps, 9.6-kHz input tone | | 60 | | |
| SINAD, SNDR | and | VDDS as reference, 200 ksps, 9.6-kHz input tone | | 63 | | dB |
| ondri | Distortion ratio | Internal 1.44-V reference, voltage scaling disabled, 32 samples average, 200 ksps, 300-Hz input tone | | 69 | | |
| | | Internal 4.3-V equivalent reference ⁽²⁾ , 200 ksps, 9.6-kHz input tone | | 67 | | |
| SFDR | Spurious-free dynamic range | VDDS as reference, 200 ksps, 9.6-kHz input tone | | 68 | | dB |
| | range | Internal 1.44-V reference, voltage scaling disabled, 32 samples average, 200 ksps, 300-Hz input tone | | 73 | | |



$T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V and voltage scaling enabled, unless otherwise noted.⁽¹⁾

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---------------------|--|-----|-------------------------------|-----|------------------|
| Conversion time | Serial conversion, time-to-output, 24-MHz clock | | 50 | | clock- cycles |
| Current consumption | Internal 4.3-V equivalent reference ⁽²⁾ | | 0.66 | | mA |
| Current consumption | VDDS as reference | | 0.75 | | mA |
| Reference voltage | Equivalent fixed internal reference (input voltage scaling | | | V | |
| Reference voltage | Fixed internal reference (input voltage scaling disabled). For best accuracy, the ADC conversion should be initiated through the TIRTOS API in order to include the gain/offset compensation factors stored in FCFG1. This value is derived from the scaled value (4.3 V) as follows: Vref = $4.3 \text{ V} \times 1408 / 4095$ | | 1.48 | | V |
| Reference voltage | VDDS as reference (Also known as <i>RELATIVE</i>) (input voltage scaling enabled) | | VDDS | | V |
| Reference voltage | VDDS as reference (Also known as <i>RELATIVE</i>) (input voltage scaling disabled) | | VDDS / 2.82 ⁽⁵⁾ | | V |
| Input impedance | 200 ksps, voltage scaling enabled. Capacitive input, Input impedance depends on sampling frequency and sampling time | | >1 | | MΩ |

(1) Using IEEE Std 1241[™]-2010 for terminology and test methods.

(2) Input signal scaled down internally before conversion, as if voltage range was 0 to 4.3 V.

(3) No missing codes. Positive DNL typically varies from +0.3 to +3.5, depending on device (see Figure 8-21).

(4) For a typical example, see Figure 8-22.

(5) Applied voltage must be within absolute maximum ratings (Section 8.1) at all times.

8.19 Temperature Sensor

Measured on the TI CC2650EM-5XD reference design with $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|-----------------|-----|-----|-----|------|
| Resolution | | | 4 | | °C |
| Range | | -40 | | 85 | °C |
| Accuracy | | | ±5 | | °C |
| Supply voltage coefficient ⁽¹⁾ | | | 3.2 | | °C/V |

(1) Automatically compensated when using supplied driver libraries.

8.20 Battery Monitor

Measured on the TI CC2650EM-5XD reference design with $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|------------|-----------------|-----|-----|-----|------|
| Resolution | | | 50 | | mV |
| Range | | 1.8 | | 3.8 | V |
| Accuracy | | | 13 | | mV |



8.21 Continuous Time Comparator

$T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---------------------------|-----|------|------|------|
| Input voltage range | | 0 | | VDDS | V |
| External reference voltage | | 0 | | VDDS | V |
| Internal reference voltage | DCOUPL as reference | | 1.27 | | V |
| Offset | | | 3 | | mV |
| Hysteresis | | | <2 | | mV |
| Decision time | Step from –10 mV to 10 mV | | 0.72 | | μs |
| Current consumption when enabled ⁽¹⁾ | | | 8.6 | | μA |

(1) Additionally, the bias module must be enabled when running in standby mode.

8.22 Low-Power Clocked Comparator

 T_c = 25°C, V_{DDS} = 3.0 V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|---------------------------|-----|-----------|------|-------------|
| Input voltage range | | 0 | | VDDS | V |
| Clock frequency | | | 32 | | kHz |
| Internal reference voltage, VDDS / 2 | | | 1.49–1.51 | | V |
| Internal reference voltage, VDDS / 3 | | | 1.01–1.03 | | V |
| Internal reference voltage, VDDS / 4 | | | 0.78–0.79 | | V |
| Internal reference voltage, DCOUPL / 1 | | | 1.25–1.28 | | V |
| Internal reference voltage, DCOUPL / 2 | | | 0.63–0.65 | | V |
| Internal reference voltage, DCOUPL / 3 | | | 0.42-0.44 | | V |
| Internal reference voltage, DCOUPL / 4 | | | 0.33–0.34 | | V |
| Offset | | | <5 | | mV |
| Hysteresis | | | <5 | | mV |
| Decision time | Step from -50 mV to 50 mV | | <1 | | clock-cycle |
| Current consumption when enabled | | | 362 | | nA |

8.23 Programmable Current Source

 $T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|---|-----|---------|-----|------|
| Current source programmable output range | | | 0.25–20 | | μA |
| Resolution | | | 0.25 | | μA |
| | Including current source at maximum programmable output | | 23 | | μA |

(1) Additionally, the bias module must be enabled when running in standby mode.



8.24 Synchronous Serial Interface (SSI)

$T_c = 25^{\circ}C$, $V_{DDS} = 3.0$ V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|--|-----|-----|-------|----------------------|
| S1 ⁽¹⁾ t _{clk_per} (SSIClk period) | Device operating as SLAVE | 12 | | 65024 | system clocks |
| S2 ⁽¹⁾ t _{clk_high} (SSIClk high time) | Device operating as SLAVE | | 0.5 | | t _{clk_per} |
| S3 ⁽¹⁾ t _{clk_low} (SSIClk low time) | Device operating as SLAVE | | 0.5 | | t _{clk_per} |
| S1 (TX only) ⁽¹⁾ t _{clk_per} (SSIClk period) | One-way communication to SLAVE - Device operating as MASTER | 4 | | 65024 | system clocks |
| S1 (TX and RX) ⁽¹⁾ t_{clk_per} (SSIClk period) | Normal duplex operation - Device operating as MASTER | 8 | | 65024 | system clocks |
| S2 ⁽¹⁾ t _{clk_high} (SSIClk high time) | Device operating as MASTER | | 0.5 | | t _{clk_per} |
| S3 ⁽¹⁾ t _{clk_low} (SSIClk low time) | Device operating as MASTER | | 0.5 | | t _{clk_per} |

(1) Refer to SSI timing diagrams Figure 8-1, Figure 8-2, and Figure 8-3.

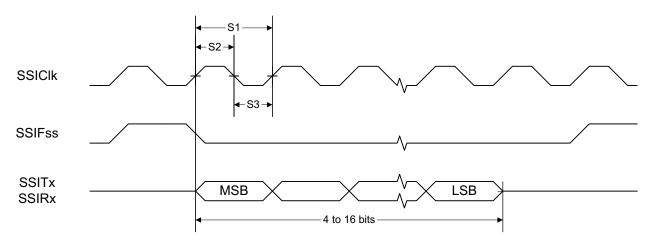
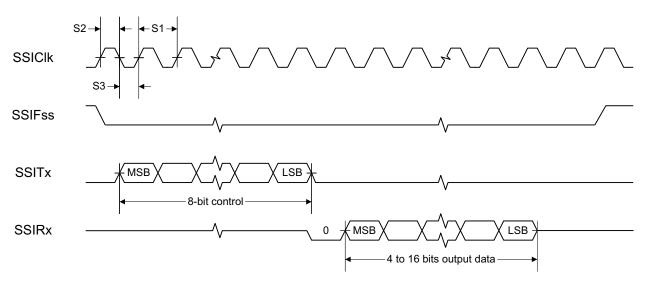
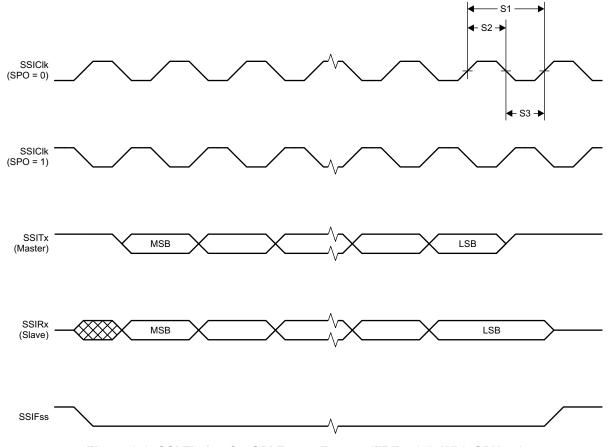


Figure 8-1. SSI Timing for TI Frame Format (FRF = 01), Single Transfer Timing Measurement











8.25 DC Characteristics

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|---|------|------|------|------|
| | T _A = 25°C, V _{DDS} = 1.8 V | | | | |
| GPIO VOH at 8-mA load | IOCURR = 2, high-drive GPIOs only | 1.32 | 1.54 | | V |
| GPIO VOL at 8-mA load | IOCURR = 2, high-drive GPIOs only | | 0.26 | 0.32 | V |
| GPIO VOH at 4-mA load | IOCURR = 1 | 1.32 | 1.58 | | V |
| GPIO VOL at 4-mA load | IOCURR = 1 | | 0.21 | 0.32 | V |
| GPIO pullup current | Input mode, pullup enabled, Vpad = 0 V | | 71.7 | | μA |
| GPIO pulldown current | Input mode, pulldown enabled, Vpad = VDDS | | 21.1 | | μA |
| GPIO high/low input transition, no hysteresis | IH = 0, transition between reading 0 and reading 1 | | 0.88 | | V |
| GPIO low-to-high input transition, with hysteresis | IH = 1, transition voltage for input read as $0 \rightarrow 1$ | | 1.07 | | V |
| GPIO high-to-low input transition, with hysteresis | IH = 1, transition voltage for input read as $1 \rightarrow 0$ | | 0.74 | | V |
| GPIO input hysteresis | IH = 1, difference between $0 \rightarrow 1$ and $1 \rightarrow 0$ points | | 0.33 | | V |
| | T _A = 25°C, V _{DDS} = 3.0 V | | | | |
| GPIO VOH at 8-mA load | IOCURR = 2, high-drive GPIOs only | | 2.68 | | V |
| GPIO VOL at 8-mA load | IOCURR = 2, high-drive GPIOs only | | 0.33 | | V |
| GPIO VOH at 4-mA load | IOCURR = 1 | | 2.72 | | V |
| GPIO VOL at 4-mA load | IOCURR = 1 | | 0.28 | | V |

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TEST CONDITIONS PARAMETER MIN TYP MAX UNIT $T_A = 25^{\circ}C, V_{DDS} = 3.8 V$ GPIO pullup current Input mode, pullup enabled, Vpad = 0 V 277 μA GPIO pulldown current Input mode, pulldown enabled, Vpad = VDDS 113 μA GPIO high/low input transition, IH = 0, transition between reading 0 and reading 1 1.67 V no hysteresis GPIO low-to-high input transition, IH = 1, transition voltage for input read as $0 \rightarrow 1$ 1.94 V with hysteresis GPIO high-to-low input transition, IH = 1, transition voltage for input read as $1 \rightarrow 0$ V 1.54 with hysteresis IH = 1, difference between $0 \rightarrow 1$ and $1 \rightarrow 0$ points V **GPIO** input hysteresis 0.4 T_A = 25°C Lowest GPIO input voltage reliably interpreted as a 0.8 VDDS(1) VIH «High» Highest GPIO input voltage reliably interpreted as a VIL VDDS(1) 0.2 «Low»

(1) Each GPIO is referenced to a specific VDDS pin. See the technical reference manual listed in Section 11.3 for more details.

8.26 Thermal Resistance Characteristics

| NAME | DESCRIPTION | RSM (°C/W) ^{(1) (2)} | RHB (°C/W) ⁽¹⁾ (2) | RGZ (°C/W) ⁽¹⁾ (2) | YFV (°C/W) ⁽¹⁾ (2) |
|-----------------------|--|-------------------------------|-------------------------------|-------------------------------|-------------------------------|
| Rθ _{JA} | Junction-to-ambient thermal resistance | 36.9 | 32.8 | 29.6 | 76.2 |
| Rθ _{JC(top)} | Junction-to-case (top) thermal resistance | 30.3 | 24.0 | 15.7 | 0.3 |
| Rθ _{JB} | Junction-to-board thermal resistance | 7.6 | 6.8 | 6.2 | 16.3 |
| Psi _{JT} | Junction-to-top characterization parameter | 0.4 | 0.3 | 0.3 | 1.8 |
| Psi _{JB} | Junction-to-board characterization parameter | 7.4 | 6.8 | 6.2 | 16.3 |
| R _{θJC(bot)} | Junction-to-case (bottom) thermal resistance | 2.1 | 1.9 | 1.9 | N/A |

(1) °C/W = degrees Celsius per watt.

(2) These values are based on a JEDEC-defined 2S2P system (with the exception of the Theta JC [Rθ_{JC}] value, which is based on a JEDEC-defined 1S0P system) and will change based on environment as well as application. For more information, see these EIA/ JEDEC standards:

- JESD51-2, Integrated Circuits Thermal Test Method Environmental Conditions Natural Convection (Still Air).
- JESD51-3, Low Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages.
- JESD51-7, High Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages.
- JESD51-9, Test Boards for Area Array Surface Mount Package Thermal Measurements.

For RSM, RHB, and RGZ, power dissipation of 2 W and an ambient temperature of 70°C is assumed. For YFV, power dissipation of 1.3 W and ambient temperature of 25°C is assumed.

8.27 Timing Requirements

| | | MIN | NOM | MAX | UNIT |
|--|--|-----|-----|-----|-------|
| Rising supply-voltage slew rate | | 0 | | 100 | mV/µs |
| Falling supply-voltage slew rate | | 0 | | 20 | mV/µs |
| Falling supply-voltage slew rate, with low-power flash settings ⁽¹⁾ | | | | 3 | mV/µs |
| Positive temperature gradient in standby ⁽²⁾ | No limitation for negative temperature gradient, or outside standby mode | | | 5 | °C/s |
| CONTROL INPUT AC CHARACTERISTICS ⁽³⁾ | | | | | |
| RESET_N low duration | | 1 | | | μs |

(1) For smaller coin cell batteries, with high worst-case end-of-life equivalent source resistance, a 22-µF VDDS input capacitor (see Figure 10-1) must be used to ensure compliance with this slew rate.

- (2) Applications using RCOSC_LF as sleep timer must also consider the drift in frequency caused by a change in temperature (see Section 8.17).
- (3) $T_A = -40^{\circ}C$ to +85°C, $V_{DDS} = 1.7$ V to 3.8 V, unless otherwise noted.



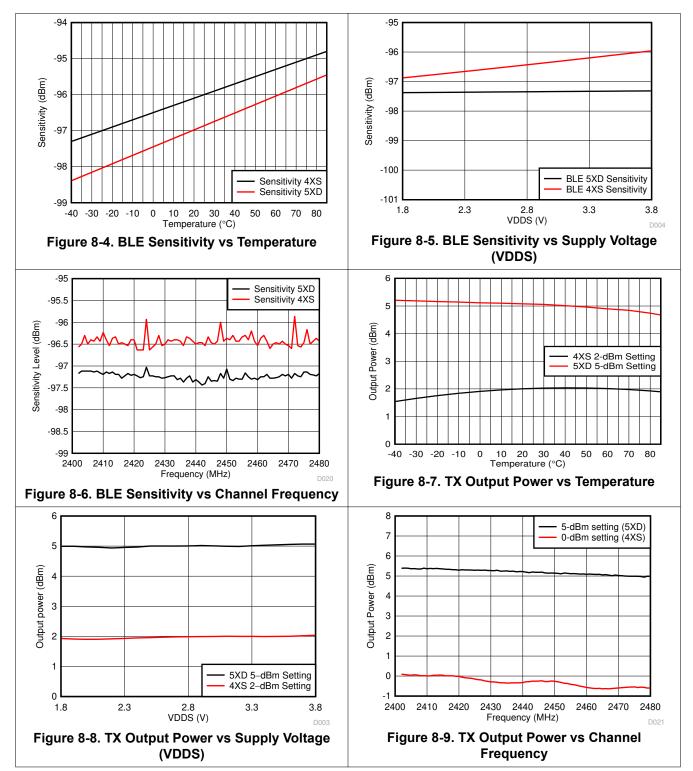
8.28 Switching Characteristics

| Measured on the TI CC2650EM-5XD refe | erence design with T_c = 25°C, V | ′ _{DDS} = 3.0 V, | unless oth | erwise | noted. | |
|--------------------------------------|--------------------------------------|---------------------------|------------|--------|--------|--|
| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT | |

| WAKEUP AND TIMING | | | | | | |
|-------------------------------|--|------|----|--|--|--|
| $Idle \to Active$ | | 14 | μs | | | |
| Standby \rightarrow Active | | 151 | μs | | | |
| Shutdown \rightarrow Active | | 1015 | μs | | | |

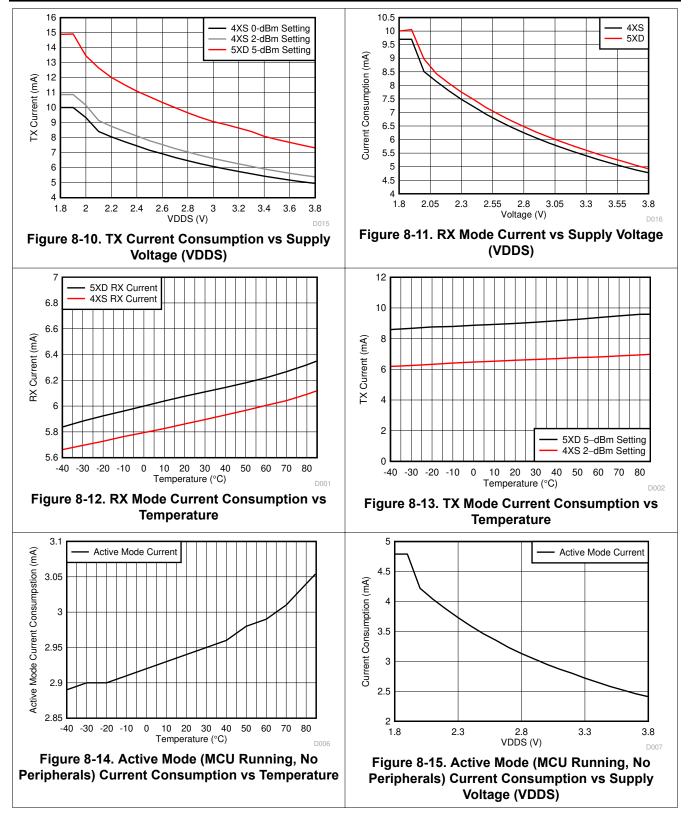


8.29 Typical Characteristics

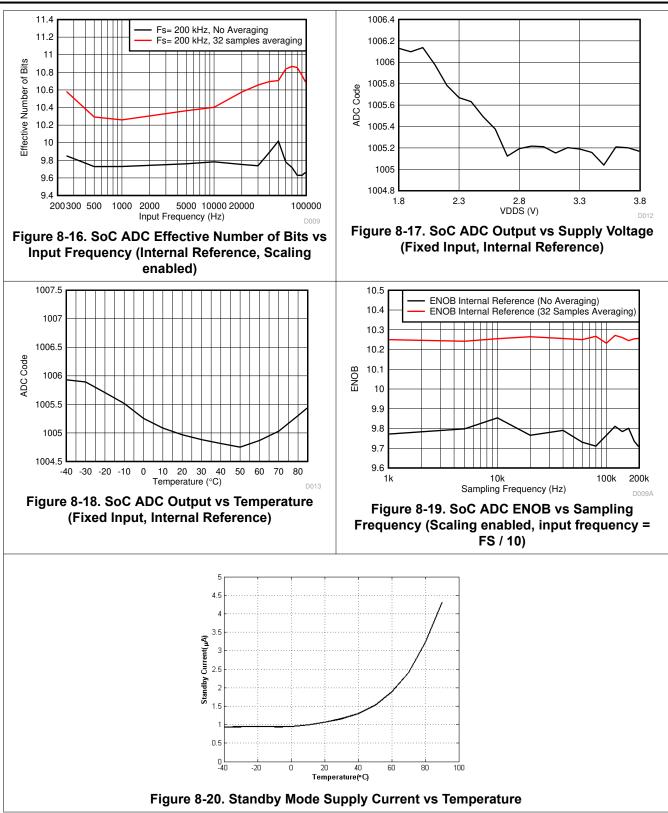




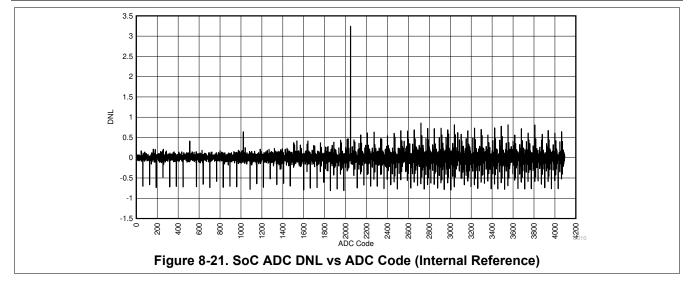
CC2640R2F SWRS204C – DECEMBER 2016 – REVISED SEPTEMBER 2020

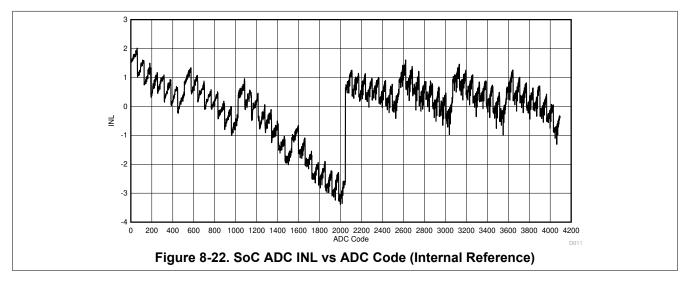












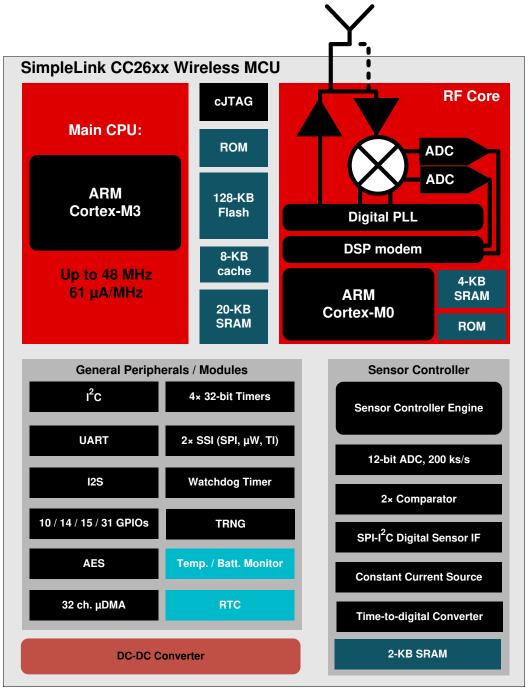


9 Detailed Description

9.1 Overview

The core modules of the CC26xx product family are shown in Section 9.2.

9.2 Functional Block Diagram



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9.3 Main CPU

The SimpleLink[™] CC2640R2F Wireless MCU contains an Arm[®] Cortex[®]-M3 (CM3) 32-bit CPU, which runs the application and the higher layers of the protocol stack.

The CM3 processor provides a high-performance, low-cost platform that meets the system requirements of minimal memory implementation, and low-power consumption, while delivering outstanding computational performance and exceptional system response to interrupts.

Arm[®] Cortex[®]-M3 features include:

- 32-bit Arm[®] Cortex[®]-M3 architecture optimized for small-footprint embedded applications
- Outstanding processing performance combined with fast interrupt handling
- Arm[®] Thumb[®]-2 mixed 16- and 32-bit instruction set delivers the high performance expected of a 32-bit Arm[®] core in a compact memory size usually associated with 8- and 16-bit devices, typically in the range of a few kilobytes of memory for microcontroller-class applications:
 - Single-cycle multiply instruction and hardware divide
 - Atomic bit manipulation (bit-banding), delivering maximum memory use and streamlined peripheral control
 - Unaligned data access, enabling data to be efficiently packed into memory
- Fast code execution permits slower processor clock or increases sleep mode time
- Harvard architecture characterized by separate buses for instruction and data
- Efficient processor core, system, and memories
- Hardware division and fast digital-signal-processing oriented multiply accumulate
- Saturating arithmetic for signal processing
- Deterministic, high-performance interrupt handling for time-critical applications
- Enhanced system debug with extensive breakpoint and trace capabilities
- Serial wire trace reduces the number of pins required for debugging and tracing
- Migration from the ARM7[™] processor family for better performance and power efficiency
- Optimized for single-cycle flash memory use
- · Ultra-low-power consumption with integrated sleep modes
- 1.25 DMIPS per MHz

9.4 RF Core

The RF Core contains an Arm[®] Cortex[®]-M0 processor that interfaces the analog RF and base-band circuits, handles data to and from the system side, and assembles the information bits in a given packet structure. The RF core offers a high level, command-based API to the main CPU.

The RF core is capable of autonomously handling the time-critical aspects of the radio protocols (Bluetooth[®] low energy) thus offloading the main CPU and leaving more resources for the user application.

The RF core has a dedicated 4-KB SRAM block and runs initially from separate ROM memory. The Arm[®] Cortex[®]-M0 processor is not programmable by customers.



9.5 Sensor Controller

The Sensor Controller contains circuitry that can be selectively enabled in standby mode. The peripherals in this domain may be controlled by the Sensor Controller Engine, which is a proprietary power-optimized CPU. This CPU can read and monitor sensors or perform other tasks autonomously, thereby significantly reducing power consumption and offloading the main CM3 CPU. The GPIOs that can be connected to the Sensor Controller are listed in Table 9-1.

The Sensor Controller is set up using a PC-based configuration tool, called Sensor Controller Studio, and potential use cases may be (but are not limited to):

- Analog sensors using integrated ADC
- Digital sensors using GPIOs, bit-banged I²C, and SPI
- UART communication for sensor reading or debugging
- Capacitive sensing
- Waveform generation
- Pulse counting
- Keyboard scan
- Quadrature decoder for polling rotation sensors
- Oscillator calibration

Note

Texas Instruments provides application examples for some of these use cases, but not for all of them.

The peripherals in the Sensor Controller include the following:

- The low-power clocked comparator can be used to wake the device from any state in which the comparator is active. A configurable internal reference can be used in conjunction with the comparator. The output of the comparator can also be used to trigger an interrupt or the ADC.
- Capacitive sensing functionality is implemented through the use of a constant current source, a time-to-digital converter, and a comparator. The continuous time comparator in this block can also be used as a higher-accuracy alternative to the low-power clocked comparator. The Sensor Controller will take care of baseline tracking, hysteresis, filtering and other related functions.
- The ADC is a 12-bit, 200-ksamples/s ADC with eight inputs and a built-in voltage reference. The ADC can be triggered by many different sources, including timers, I/O pins, software, the analog comparator, and the RTC.
- The Sensor Controller also includes a SPI–I²C digital interface.
- The analog modules can be connected to up to eight different GPIOs.

The peripherals in the Sensor Controller can also be controlled from the main application processor.

| Idu | ie 9-1. GFIUS CU | Table 5-1. GPIOS Connected to the Sensor Controller (* | | | | | | | | | | | |
|-------------------|-------------------------|--|-----------------------------|-------------------------|--|--|--|--|--|--|--|--|--|
| ANALOG CAPABLE | 7 × 7 RGZ DIO NUMBER | 5 × 5 RHB DIO NUMBER | 2.7 × 2.7 YFV DIO NUMBER | 4 × 4 RSM DIO NUMBER | | | | | | | | | |
| Y | 30 | 14 | | | | | | | | | | | |
| Y | 29 | 13 | 13 | | | | | | | | | | |
| Y | 28 | 12 | 12 | | | | | | | | | | |
| Y | 27 | 11 | 11 | 9 | | | | | | | | | |
| Y | 26 | 9 | 9 | 8 | | | | | | | | | |
| Y | 25 | 10 | 10 | 7 | | | | | | | | | |
| Y | 24 | 8 | 8 | 6 | | | | | | | | | |
| Y | 23 | 7 | 7 | 5 | | | | | | | | | |
| Ν | 7 | 4 | 4 | 2 | | | | | | | | | |
| Ν | 6 | 3 | 3 | 1 | | | | | | | | | |
| N | 5 | 2 | 2 | 0 | | | | | | | | | |

| | | | | , sommada, |
|-------------------|-------------------------|-------------------------|-----------------------------|-------------------------|
| ANALOG CAPABLE | 7 × 7 RGZ DIO NUMBER | 5 × 5 RHB DIO NUMBER | 2.7 × 2.7 YFV DIO NUMBER | 4 × 4 RSM DIO NUMBER |
| Ν | 4 | 1 | 1 | |
| N | 3 | 0 | 0 | |
| N | 2 | | | |
| N | 1 | | | |
| N | 0 | | | |

Table 9-1. GPIOs Connected to the Sensor Controller ⁽¹⁾ (continued)

(1) Depending on the package size, up to 16 pins can be connected to the Sensor Controller. Up to 8 of these pins can be connected to analog modules.

9.6 Memory

The Flash memory provides nonvolatile storage for code and data. The Flash memory is in-system programmable.

The SRAM (static RAM) can be used for both storage of data and execution of code and is split into two 4-KB blocks and two 6-KB blocks. Retention of the RAM contents in standby mode can be enabled or disabled individually for each block to minimize power consumption. In addition, if flash cache is disabled, the 8-KB cache can be used as a general-purpose RAM.

The ROM provides preprogrammed embedded TI-RTOS kernel, Driverlib, and lower layer protocol stack software (Bluetooth low energy Controller). It also contains a bootloader that can be used to reprogram the device using SPI or UART. For CC2640R2Fxxx devices, the ROM contains Bluetooth 4.2 low energy host- and controller software libraries, leaving more of the flash memory available for the customer application.

9.7 Debug

The on-chip debug support is done through a dedicated cJTAG (IEEE 1149.7) or JTAG (IEEE 1149.1) interface.

9.8 Power Management

To minimize power consumption, the CC2640R2F device supports a number of power modes and power management features (see Table 9-2).

| | | 9-2. Power Modes | | | |
|---|------------------------|------------------------|------------------------|-----------|-----------|
| MODE | SOFTW | ARE CONFIGURABLE | POWER MODES | | RESET PIN |
| | ACTIVE | IDLE | STANDBY | SHUTDOWN | HELD |
| CPU | Active | Off | Off | Off | Off |
| Flash | On | Available | Off | Off | Off |
| SRAM | On | On | On | Off | Off |
| Radio | Available | Available | Off | Off | Off |
| Supply System | On | On | Duty Cycled | Off | Off |
| Current | 1.45 mA + 31 µA/MHz | 650 µA | 1 µA | 0.15 µA | 0.1 µA |
| Wake-up Time to CPU Active ⁽¹⁾ | - | 14 µs | 151 µs | 1015 µs | 1015 µs |
| Register Retention | Full | Full | Partial | No | No |
| SRAM Retention | Full | Full | Full | No | No |
| High-Speed Clock | XOSC_HF or RCOSC_HF | XOSC_HF or RCOSC_HF | Off | Off | Off |
| Low-Speed Clock | XOSC_LF or RCOSC_LF | XOSC_LF or RCOSC_LF | XOSC_LF or RCOSC_LF | Off | Off |
| Peripherals | Available | Available | Off | Off | Off |
| Sensor Controller | Available | Available | Available | Off | Off |
| Wake up on RTC | Available | Available | Available | Off | Off |
| Wake up on Pin Edge | Available | Available | Available | Available | Off |

Table 9-2. Power Modes



| MODE | SOFTV | RESET PIN | | | |
|--------------------------|-----------|-----------|-------------|-----------|-----------|
| | ACTIVE | IDLE | STANDBY | SHUTDOWN | HELD |
| Wake up on Reset Pin | Available | Available | Available | Available | Available |
| Brown Out Detector (BOD) | Active | Active | Duty Cycled | Off | N/A |
| Power On Reset (POR) | Active | Active | Active | Active | N/A |

Table 9-2. Power Modes (continued)

(1) Not including RTOS overhead

In active mode, the application CM3 CPU is actively executing code. Active mode provides normal operation of the processor and all of the peripherals that are currently enabled. The system clock can be any available clock source (see Table 9-2).

In idle mode, all active peripherals can be clocked, but the Application CPU core and memory are not clocked and no code is executed. Any interrupt event will bring the processor back into active mode.

In standby mode, only the always-on domain (AON) is active. An external wake-up event, RTC event, or sensorcontroller event is required to bring the device back to active mode. MCU peripherals with retention do not need to be reconfigured when waking up again, and the CPU continues execution from where it went into standby mode. All GPIOs are latched in standby mode.

In shutdown mode, the device is turned off entirely, including the AON domain and the Sensor Controller. The I/Os are latched with the value they had before entering shutdown mode. A change of state on any I/O pin defined as a *wake-up from Shutdown pin* wakes up the device and functions as a reset trigger. The CPU can differentiate between a reset in this way, a reset-by-reset pin, or a power-on-reset by reading the reset status register. The only state retained in this mode is the latched I/O state and the Flash memory contents.

The Sensor Controller is an autonomous processor that can control the peripherals in the Sensor Controller independently of the main CPU, which means that the main CPU does not have to wake up, for example, to execute an ADC sample or poll a digital sensor over SPI. The main CPU saves both current and wake-up time that would otherwise be wasted. The Sensor Controller Studio enables the user to configure the sensor controller and choose which peripherals are controlled and which conditions wake up the main CPU.

9.9 Clock Systems

The CC2640R2F supports two external and two internal clock sources.

A 24-MHz crystal is required as the frequency reference for the radio. This signal is doubled internally to create a 48-MHz clock.

The 32-kHz crystal is optional. *Bluetooth* low energy requires a slow-speed clock with better than ±500 ppm accuracy if the device is to enter any sleep mode while maintaining a connection. The internal 32-kHz RC oscillator can in some use cases be compensated to meet the requirements. The low-speed crystal oscillator is designed for use with a 32-kHz watch-type crystal.

The internal high-speed oscillator (48-MHz) can be used as a clock source for the CPU subsystem.

The internal low-speed oscillator (32.768-kHz) can be used as a reference if the low-power crystal oscillator is not used.

The 32-kHz clock source can be used as external clocking reference through GPIO.

9.10 General Peripherals and Modules

The I/O controller controls the digital I/O pins and contains multiplexer circuitry to allow a set of peripherals to be assigned to I/O pins in a flexible manner. All digital I/Os are interrupt and wake-up capable, have a programmable pullup and pulldown function and can generate an interrupt on a negative or positive edge (configurable). When configured as an output, pins can function as either push-pull or open-drain. Five GPIOs have high drive capabilities (marked in **bold** in Section 7).

The SSIs are synchronous serial interfaces that are compatible with SPI, MICROWIRE, and Texas Instruments synchronous serial interfaces. The SSIs support both SPI master and slave up to 4 MHz.



The UART implements a universal asynchronous receiver/transmitter function. It supports flexible baud-rate generation up to a maximum of 3 Mbps .

Timer 0 is a general-purpose timer module (GPTM), which provides two 16-bit timers. The GPTM can be configured to operate as a single 32-bit timer, dual 16-bit timers or as a PWM module.

Timer 1, Timer 2, and Timer 3 are also GPTMs. Each of these timers is functionally equivalent to Timer 0.

In addition to these four timers, the RF core has its own timer to handle timing for RF protocols; the RF timer can be synchronized to the RTC.

The I²C interface is used to communicate with devices compatible with the I²C standard. The I²C interface is capable of 100-kHz and 400-kHz operation, and can serve as both I²C master and I²C slave.

The TRNG module provides a true, nondeterministic noise source for the purpose of generating keys, initialization vectors (IVs), and other random number requirements. The TRNG is built on 24 ring oscillators that create unpredictable output to feed a complex nonlinear combinatorial circuit.

The watchdog timer is used to regain control if the system fails due to a software error after an external device fails to respond as expected. The watchdog timer can generate an interrupt or a reset when a predefined time-out value is reached.

The device includes a direct memory access (μ DMA) controller. The μ DMA controller provides a way to offload data transfer tasks from the CM3 CPU, allowing for more efficient use of the processor and the available bus bandwidth. The μ DMA controller can perform transfer between memory and peripherals. The μ DMA controller has dedicated channels for each supported on-chip module and can be programmed to automatically perform transfers between peripherals and memory as the peripheral is ready to transfer more data. Some features of the μ DMA controller include the following (this is not an exhaustive list):

- Highly flexible and configurable channel operation of up to 32 channels
- Transfer modes:
 - Memory-to-memory
 - Memory-to-peripheral
 - Peripheral-to-memory
 - Peripheral-to-peripheral
- Data sizes of 8, 16, and 32 bits

The AON domain contains circuitry that is always enabled, except for in Shutdown (where the digital supply is off). This circuitry includes the following:

- The RTC can be used to wake the device from any state where it is active. The RTC contains three compare and one capture registers. With software support, the RTC can be used for clock and calendar operation. The RTC is clocked from the 32-kHz RC oscillator or crystal. The RTC can also be compensated to tick at the correct frequency even when the internal 32-kHz RC oscillator is used instead of a crystal.
- The battery monitor and temperature sensor are accessible by software and give a battery status indication as well as a coarse temperature measure.



9.11 Voltage Supply Domains

The CC2640R2F device can interface to two or three different voltage domains depending on the package type. On-chip level converters ensure correct operation as long as the signal voltage on each input/output pin is set with respect to the corresponding supply pin (VDDS, VDDS2 or VDDS3). Table 9-3 lists the pin-to-VDDS mapping.

| | Package | | | | | | | | | |
|---------------------|----------------------|---------------------|--------------------|---------------------|--|--|--|--|--|--|
| | VQFN 7 × 7 (RGZ) | VQFN 4 × 4 (RSM) | DSBGA (YFV) | | | | | | | |
| VDDS ⁽¹⁾ | DIO 23–30 Reset_N | DIO 7–14 Reset_N | DIO 5–9 Reset_N | DIO 7–13 Reset_N | | | | | | |
| VDDS2 | DIO 0–11 | DIO 0–6 JTAG | DIO 0–4 JTAG | DIO 0–6 JTAG | | | | | | |
| VDDS3 | DIO 12–22 JTAG | N/A | N/A | N/A | | | | | | |

| Table 9-3. | Pin Function | to VDDS | Mapping | Table |
|------------|---------------------|---------|---------|-------|
|------------|---------------------|---------|---------|-------|

(1) VDDS_DCDC must be connected to VDDS on the PCB.

9.12 System Architecture

Depending on the product configuration, CC26xx can function either as a Wireless Network Processor (WNP an IC running the wireless protocol stack, with the application running on a separate MCU), or as a System-on-Chip (SoC), with the application and protocol stack running on the Arm[®] Cortex[®]-M3 core inside the device.

In the first case, the external host MCU communicates with the device using SPI or UART. In the second case, the application must be written according to the application framework supplied with the wireless protocol stack.



10 Application, Implementation, and Layout

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

Very few external components are required for the operation of the CC2640R2F device. This section provides some general information about the various configuration options when using the CC2640R2F in an application, and then shows two examples of application circuits with schematics and layout. This is only a small selection of the many application circuit examples available as complete reference designs from the product folder on www.ti.com.

Figure 10-1 shows the various RF front-end configuration options. The RF front end can be used in differentialor single-ended configurations with the options of having internal or external biasing. These options allow for various trade-offs between cost, board space, and RF performance. Differential operation with external bias gives the best performance while single-ended operation with internal bias gives the least amount of external components and the lowest power consumption. Reference designs exist for each of these options.

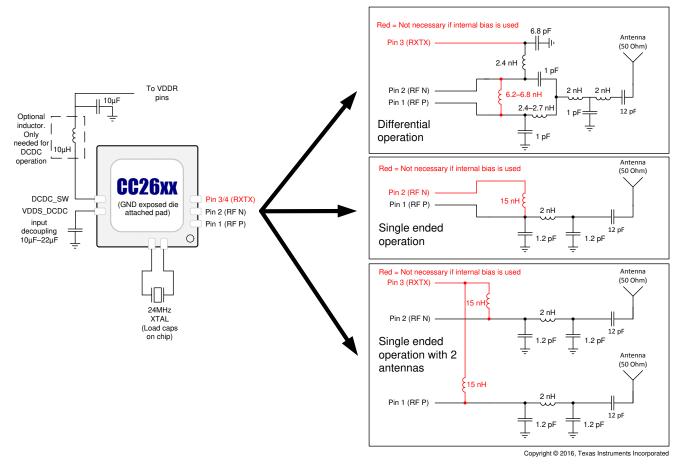


Figure 10-1. CC2640R2F Application Circuit



Figure 10-2 shows the various supply voltage configuration options. Not all power supply decoupling capacitors or digital I/Os are shown. Exact pin positions will vary between the different package options. For a detailed overview of power supply decoupling and wiring, see the TI reference designs and the CC26xx technical reference manual (Section 11.3).

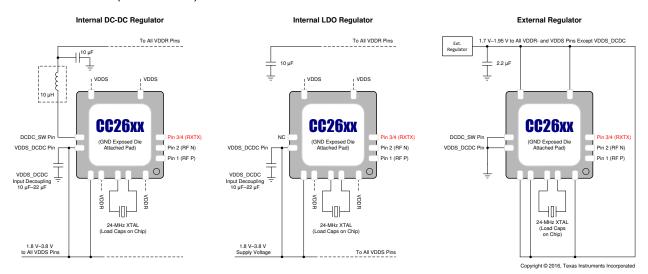
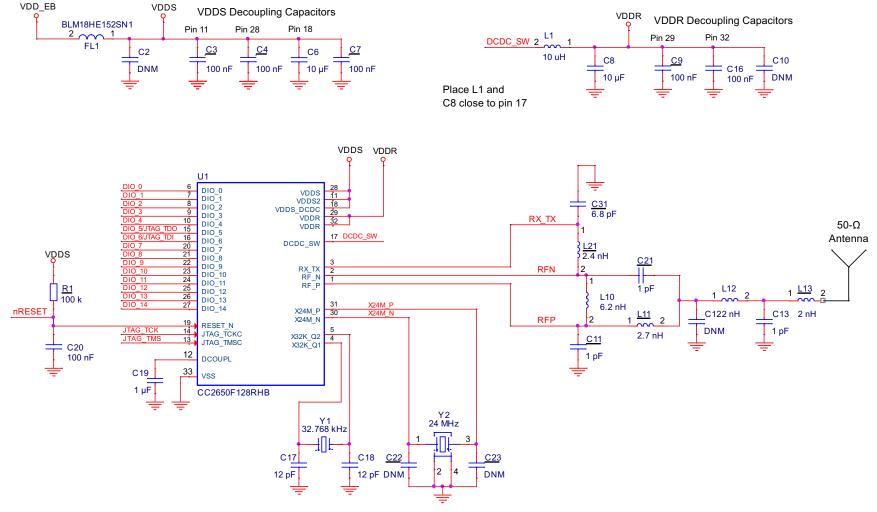


Figure 10-2. Supply Voltage Configurations



10.2 5 × 5 External Differential (5XD) Application Circuit



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Figure 10-3. 5 × 5 External Differential (5XD) Application Circuit

10.2.1 Layout



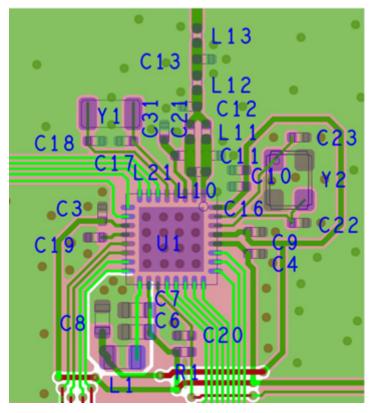
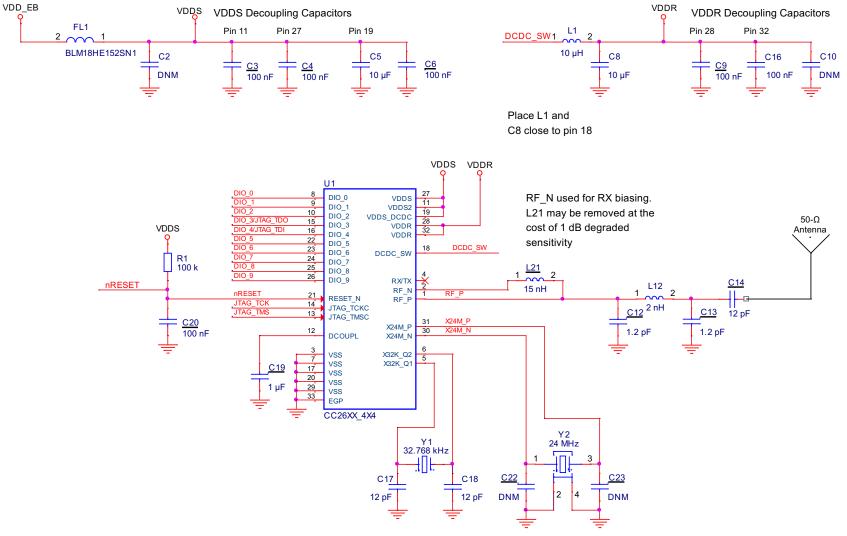


Figure 10-4. 5 × 5 External Differential (5XD) Layout







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Figure 10-5. 4 × 4 External Single-ended (4XS) Application Circuit



10.3.1 Layout

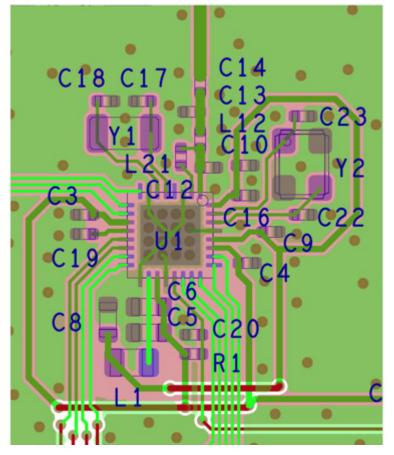


Figure 10-6. 4 × 4 External Single-ended (4XS) Layout



11 Device and Documentation Support

11.1 Device Nomenclature

To designate the stages in the product development cycle, TI assigns prefixes to all pre-production part numbers or date-code markings. Each device has one of three prefixes/identifications: X, P, or null (no prefix) (for example, CC2640R2F is in production; therefore, no prefix/identification is assigned).

Device development evolutionary flow:

- **X** Experimental device that is not necessarily representative of the final device's electrical specifications and may not use production assembly flow.
- **P** Prototype device that is not necessarily the final silicon die and may not necessarily meet final electrical specifications.

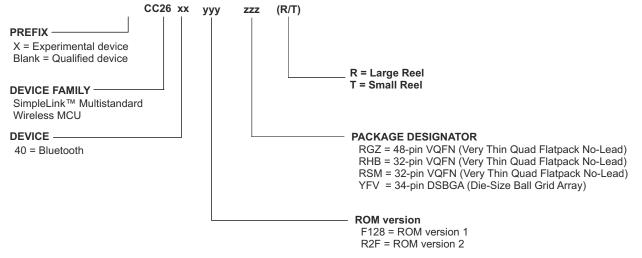
null Production version of the silicon die that is fully qualified.

Production devices have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI's standard warranty applies.

Predictions show that prototype devices (X or P) have a greater failure rate than the standard production devices. Texas Instruments recommends that these devices not be used in any production system because their expected end-use failure rate still is undefined. Only qualified production devices are to be used.

TI device nomenclature also includes a suffix with the device family name. This suffix indicates the package type (for example,).

For orderable part numbers of the *CC2640R2F* device *RSM*, *RHB*, *RGZ*, *or YFV* package types, see the Package Option Addendum of this document, the TI website (www.ti.com), or contact your TI sales representative.







11.2 Tools and Software

TI offers an extensive line of development tools, including tools to evaluate the performance of the processors, generate code, develop algorithm implementations, and fully integrate and debug software and hardware modules.

The following products support development of the CC2640R2F device applications:

Software Tools:

SmartRF Studio 7 is a PC application that helps designers of radio systems to easily evaluate the RF-IC at an early stage in the design process.

- Test functions for sending and receiving radio packets, continuous wave transmit and receive
- · Evaluate RF performance on custom boards by wiring it to a supported evaluation board or debugger
- Can also be used without any hardware, but then only to generate, edit and export radio configuration settings
- · Can be used in combination with several development kits for Texas Instruments' CCxxxx RF-ICs

Sensor Controller Studio provides a development environment for the CC26xx Sensor Controller. The Sensor Controller is a proprietary, power-optimized CPU in the CC26xx, which can perform simple background tasks autonomously and independent of the System CPU state.

- Allows for Sensor Controller task algorithms to be implemented using a C-like programming language
- Outputs a Sensor Controller Interface driver, which incorporates the generated Sensor Controller machine code and associated definitions
- Allows for rapid development by using the integrated Sensor Controller task testing and debugging functionality. This allows for live visualization of sensor data and algorithm verification.

IDEs and Compilers:

Code Composer Studio[™] Integrated Development Environment (IDE):

- Integrated development environment with project management tools and editor
- Code Composer Studio (CCS) 7.0 and later has built-in support for the CC26xx device family
- Best support for XDS debuggers; XDS100v3, XDS110 and XDS200
- High integration with TI-RTOS with support for TI-RTOS Object View

IAR Embedded Workbench[®] for Arm[®]:

- Integrated development environment with project management tools and editor
- IAR EWARM 7.80.1 and later has built-in support for the CC26xx device family
- Broad debugger support, supporting XDS100v3, XDS200, IAR I-Jet and Segger J-Link
- Integrated development environment with project management tools and editor
- RTOS plugin available for TI-RTOS

For a complete listing of development-support tools for the CC2640R2F platform, visit the Texas Instruments website at www.ti.com . For information on pricing and availability, contact the nearest TI field sales office or authorized distributor.



11.3 Documentation Support

To receive notification of documentation updates, navigate to the device product folder on ti.com (CC2640R2F). In the upper right corner, click on Alert me to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

The current documentation that describes the CC2640R2F devices, related peripherals, and other technical collateral is listed in the following.

Technical Reference Manual

CC13xx, CC26xx SimpleLink™ Wireless MCU Technical Reference Manual

11.4 Texas Instruments Low-Power RF Website

Texas Instruments' Low-Power RF website has all the latest products, application and design notes, FAQ section, news and events updates. Go to www.ti.com/lprf.

11.5 Low-Power RF eNewsletter

The Low-Power RF eNewsletter is up-to-date on new products, news releases, developers' news, and other news and events associated with low-power RF products from TI. The Low-Power RF eNewsletter articles include links to get more online information.

Sign up at: www.ti.com/lprfnewsletter

11.6 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

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11.8 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.9 Export Control Notice

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11.10 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.



12 Mechanical, Packaging, and Orderable Information

12.1 Packaging Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|-----------------|-------------------------------|----------------------|--------------|-------------------------|---------|
| | | | | | | | (6) | | | | |
| CC2640R2FRGZR | ACTIVE | VQFN | RGZ | 48 | 2500 | RoHS & Green | NIPDAU NIPDAUAG | Level-3-260C-168 HR | -40 to 85 | CC2640 R2F | Samples |
| CC2640R2FRGZT | ACTIVE | VQFN | RGZ | 48 | 250 | RoHS & Green | NIPDAU NIPDAUAG | Level-3-260C-168 HR | -40 to 85 | CC2640 R2F | Samples |
| CC2640R2FRHBR | ACTIVE | VQFN | RHB | 32 | 2500 | RoHS & Green | NIPDAU NIPDAUAG | Level-3-260C-168 HR | -40 to 85 | CC2640 R2F | Samples |
| CC2640R2FRHBT | ACTIVE | VQFN | RHB | 32 | 250 | RoHS & Green | NIPDAU NIPDAUAG | Level-3-260C-168 HR | -40 to 85 | CC2640 R2F | Samples |
| CC2640R2FRSMR | ACTIVE | VQFN | RSM | 32 | 3000 | RoHS & Green | NIPDAU NIPDAUAG | Level-3-260C-168 HR | -40 to 85 | CC2640 R2F | Samples |
| CC2640R2FRSMT | ACTIVE | VQFN | RSM | 32 | 250 | RoHS & Green | NIPDAU NIPDAUAG | Level-3-260C-168 HR | -40 to 85 | CC2640 R2F | Samples |
| CC2640R2FYFVR | ACTIVE | DSBGA | YFV | 34 | 2500 | RoHS & Green | SNAGCU | Level-1-260C-UNLIM | -40 to 85 | CC2640 | Samples |
| CC2640R2FYFVT | ACTIVE | DSBGA | YFV | 34 | 250 | RoHS & Green | SNAGCU | Level-1-260C-UNLIM | -40 to 85 | CC2640 | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



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PACKAGE OPTION ADDENDUM

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CC2640R2F :

Automotive : CC2640R2F-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects



Texas

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



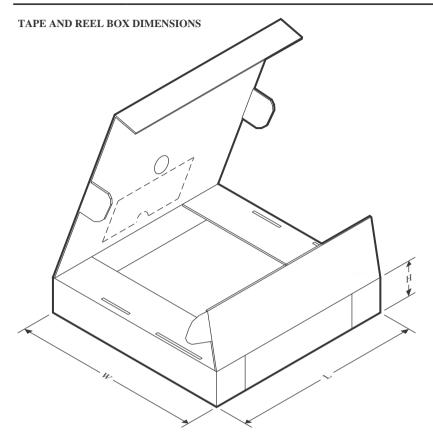
| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|---------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| CC2640R2FRGZT | VQFN | RGZ | 48 | 250 | 180.0 | 16.4 | 7.3 | 7.3 | 1.1 | 12.0 | 16.0 | Q2 |
| CC2640R2FRHBR | VQFN | RHB | 32 | 2500 | 330.0 | 12.4 | 5.3 | 5.3 | 1.1 | 8.0 | 12.0 | Q2 |
| CC2640R2FRHBT | VQFN | RHB | 32 | 250 | 180.0 | 12.4 | 5.3 | 5.3 | 1.1 | 8.0 | 12.0 | Q2 |
| CC2640R2FYFVR | DSBGA | YFV | 34 | 2500 | 180.0 | 8.4 | 2.75 | 2.75 | 0.81 | 4.0 | 8.0 | Q1 |
| CC2640R2FYFVT | DSBGA | YFV | 34 | 250 | 180.0 | 8.4 | 2.75 | 2.75 | 0.81 | 4.0 | 8.0 | Q1 |



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PACKAGE MATERIALS INFORMATION

25-Sep-2024



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|---------------|--------------|-----------------|------|------|-------------|------------|-------------|
| CC2640R2FRGZT | VQFN | RGZ | 48 | 250 | 210.0 | 185.0 | 35.0 |
| CC2640R2FRHBR | VQFN | RHB | 32 | 2500 | 367.0 | 367.0 | 35.0 |
| CC2640R2FRHBT | VQFN | RHB | 32 | 250 | 210.0 | 185.0 | 35.0 |
| CC2640R2FYFVR | DSBGA | YFV | 34 | 2500 | 182.0 | 182.0 | 20.0 |
| CC2640R2FYFVT | DSBGA | YFV | 34 | 250 | 182.0 | 182.0 | 20.0 |

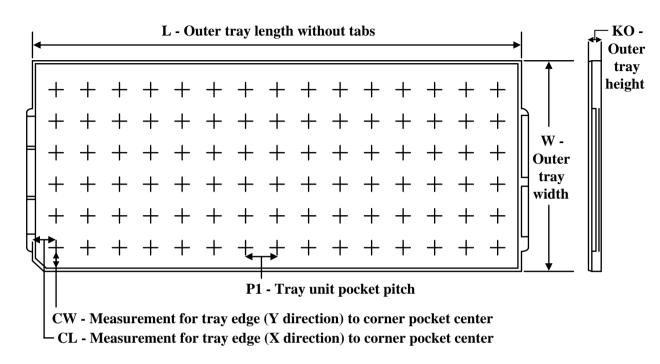
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TRAY



PACKAGE MATERIALS INFORMATION



Chamfer on Tray corner indicates Pin 1 orientation of packed units.

| Device | Package Name | Package Type | Pins | SPQ | Unit array matrix | Max temperature (°C) | L (mm) | W (mm) | K0 (µm) | P1 (mm) | CL (mm) | CW (mm) |
|---------------|-----------------|-----------------|------|------|----------------------|----------------------------|--------|-----------|------------|------------|------------|------------|
| CC2640R2FRHBR | RHB | VQFN | 32 | 2500 | 14 x 35 | 150 | 315 | 135.9 | 7620 | 8.8 | 7.9 | 8.15 |
| CC2640R2FRHBR | RHB | VQFN | 32 | 2500 | 14 x 35 | 150 | 315 | 135.9 | 7620 | 8.8 | 7.9 | 8.15 |
| CC2640R2FRHBT | RHB | VQFN | 32 | 250 | 14 x 35 | 150 | 315 | 135.9 | 7620 | 8.8 | 7.9 | 8.15 |
| CC2640R2FRHBT | RHB | VQFN | 32 | 250 | 14 x 35 | 150 | 315 | 135.9 | 7620 | 8.8 | 7.9 | 8.15 |
| CC2640R2FRSMR | RSM | VQFN | 32 | 3000 | 14 x 35 | 150 | 315 | 135.9 | 7620 | 8.8 | 7.9 | 8.15 |
| CC2640R2FRSMT | RSM | VQFN | 32 | 250 | 14 x 35 | 150 | 315 | 135.9 | 7620 | 8.8 | 7.9 | 8.15 |
| CC2640R2FRSMT | RSM | VQFN | 32 | 250 | 14 x 35 | 150 | 315 | 135.9 | 7620 | 8.8 | 7.9 | 8.15 |

*All dimensions are nominal

25-Sep-2024

RHB 32

5 x 5, 0.5 mm pitch

GENERIC PACKAGE VIEW

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



RHB0032E



PACKAGE OUTLINE

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



RHB0032E

EXAMPLE BOARD LAYOUT

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

 Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

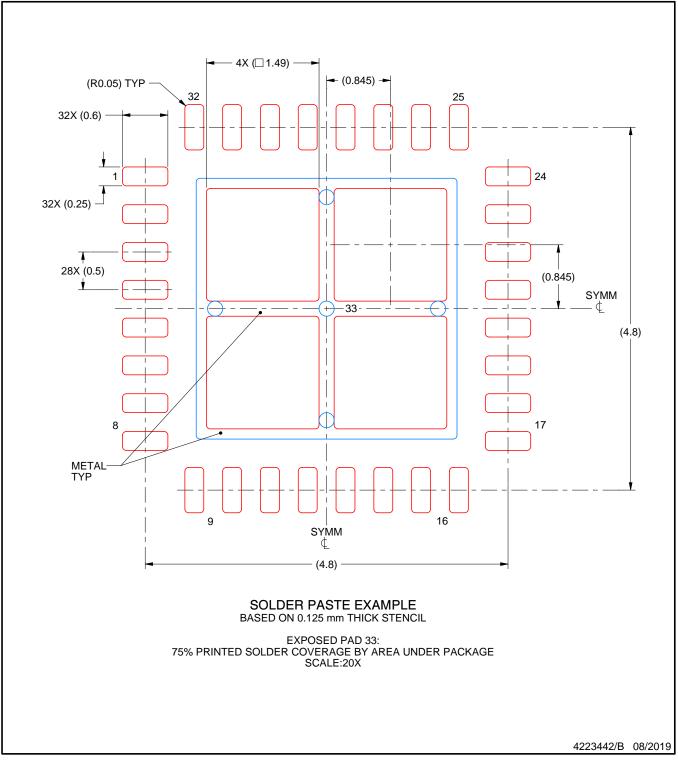


RHB0032E

EXAMPLE STENCIL DESIGN

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



RGZ 48

7 x 7, 0.5 mm pitch

GENERIC PACKAGE VIEW

VQFN - 1 mm max height

PLASTIC QUADFLAT PACK- NO LEAD



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



RGZ0048A

PACKAGE OUTLINE VQFN - 1 mm max height

VQ: IT I IIII IIIAX Holgit

PLASTIC QUADFLAT PACK- NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



EXAMPLE BOARD LAYOUT

VQFN - 1 mm max height

PLASTIC QUADFLAT PACK- NO LEAD



NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



RGZ0048A

EXAMPLE STENCIL DESIGN

VQFN - 1 mm max height

PLASTIC QUADFLAT PACK- NO LEAD



6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



RSM 32

4 x 4, 0.4 mm pitch

GENERIC PACKAGE VIEW

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





4224982/A

RSM0032B



PACKAGE OUTLINE

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



RSM0032B

EXAMPLE BOARD LAYOUT

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

 Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



RSM0032B

EXAMPLE STENCIL DESIGN

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



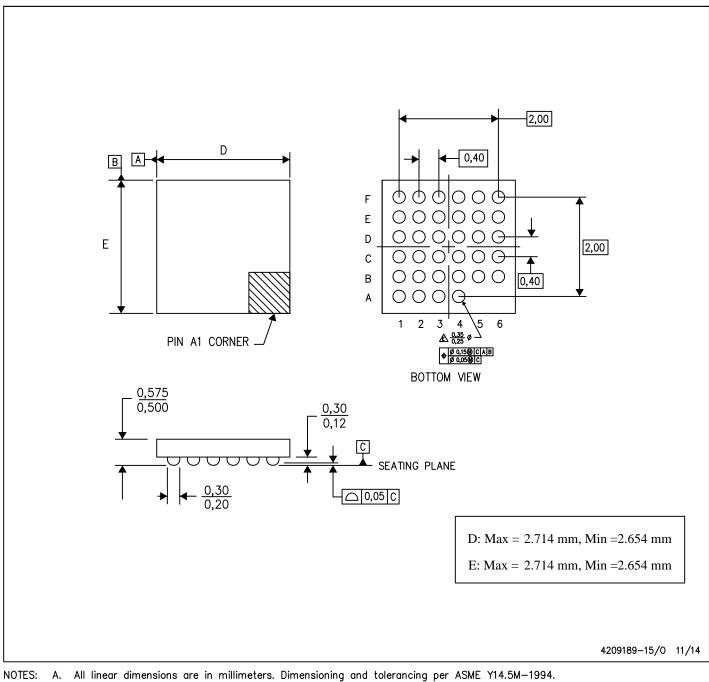
NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



YFV (R-XBGA-N34)

DIE-SIZE BALL GRID ARRAY (WCSP)



- This drawing is subject to change without notice. В.
- NanoFree™ package configuration. C.
- D. This package contains Pb-free balls.

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